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(54) ORGANIC LIGHT EMITTING DISPLAY DEVICE AND METHOD OF FABRICATING THE SAME

6,858,991 B2 * 2/2005 Miyazawa 315/169.3
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* cited by examiner

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(21) Appl. No.: 10/667,906

(57) ABSTRACT

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An apparatus for providing a driving signal to an organic light emitting diode in an image display device includes gate lines for transferring previous and current gate signals, respectively, in a sequential process for providing the driving signal to the organic light emitting diode, a data line for transferring a data signal for displaying images on the image display device, a first switching transistor including a conduction path for transferring the data signal from the data line in response to the current gate signal; a second switching transistor including a conduction path for transferring a reference signal externally supplied in response to the previous gate signal, a third switching transistor including a conduction path for transferring the data signal provided from the first switching transistor in response to a state of the second switching transistor, and a fourth switching transistor including a conduction path for receiving a bias voltage and generating the driving signal to the organic light emitting diode in response to one of the reference signal from the second switching transistor and the data signal from the third switching transistor. The third and fourth switching transistors have switching characteristics substantially identical to each other.

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G09G 3/32 (2006.01)

G09G 3/18 (2006.01)

(52) U.S. Cl. 345/82; 345/76; 315/169.3

(58) Field of Classification Search 345/76-83;
315/169.3

See application file for complete search history.

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34 Claims, 18 Drawing Sheets

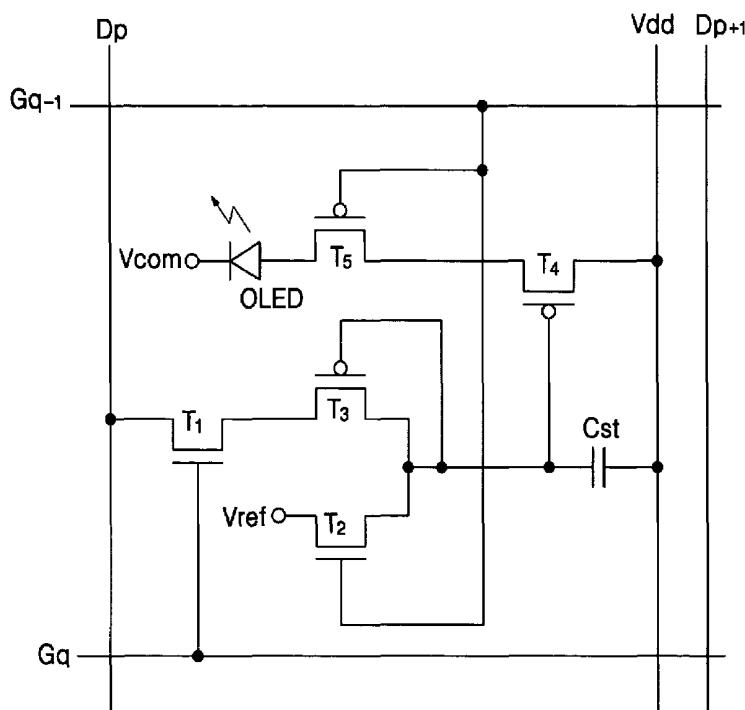


FIG.1
(PRIOR ART)

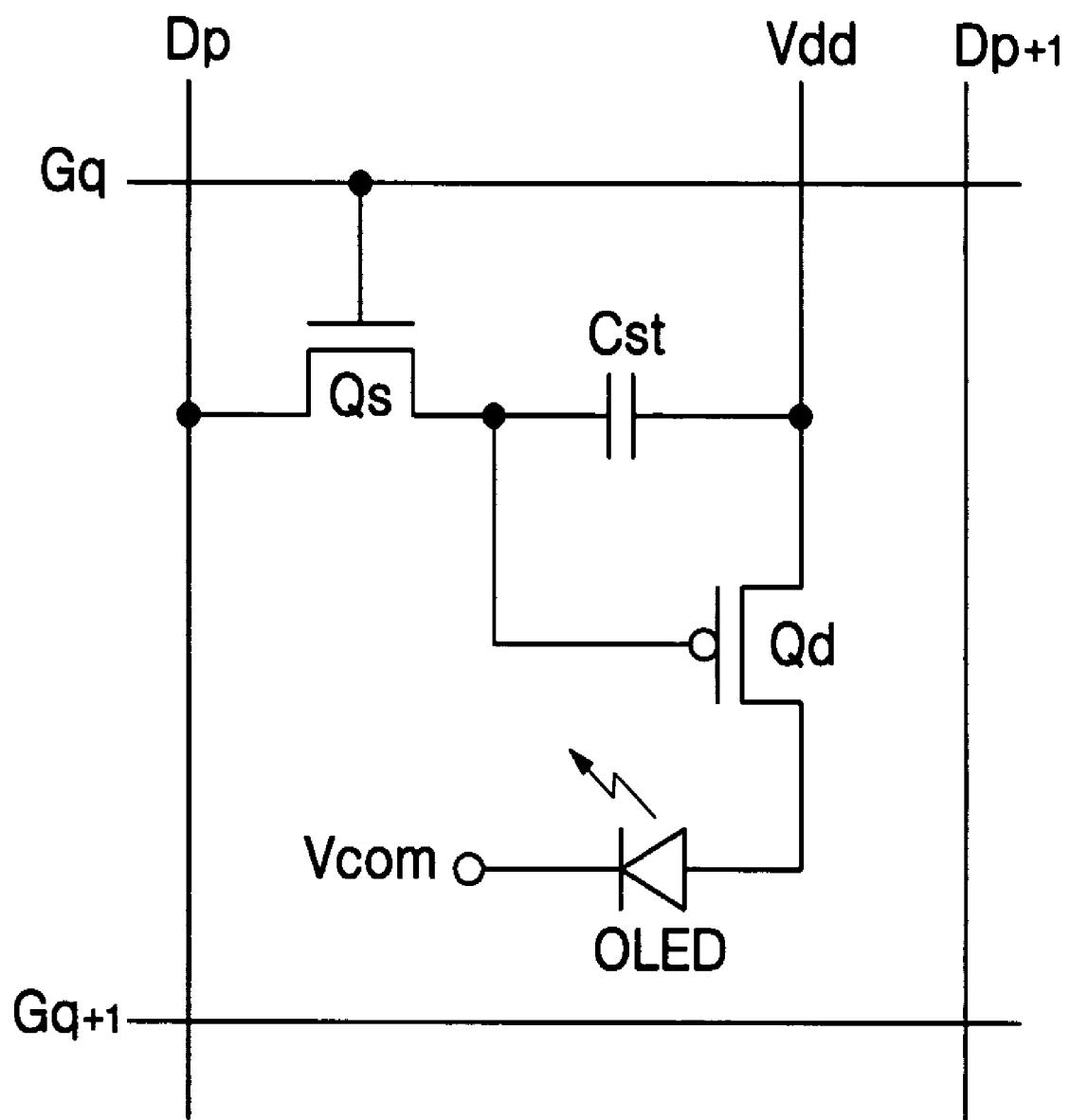


FIG.2
(PRIOR ART)

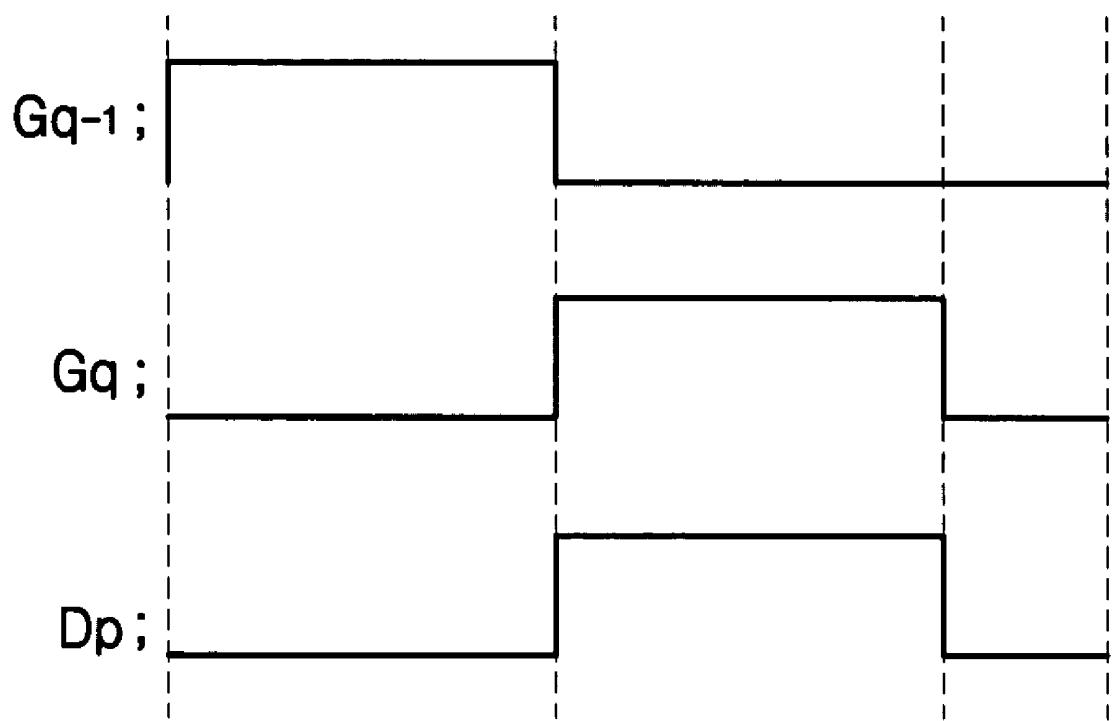


FIG.3

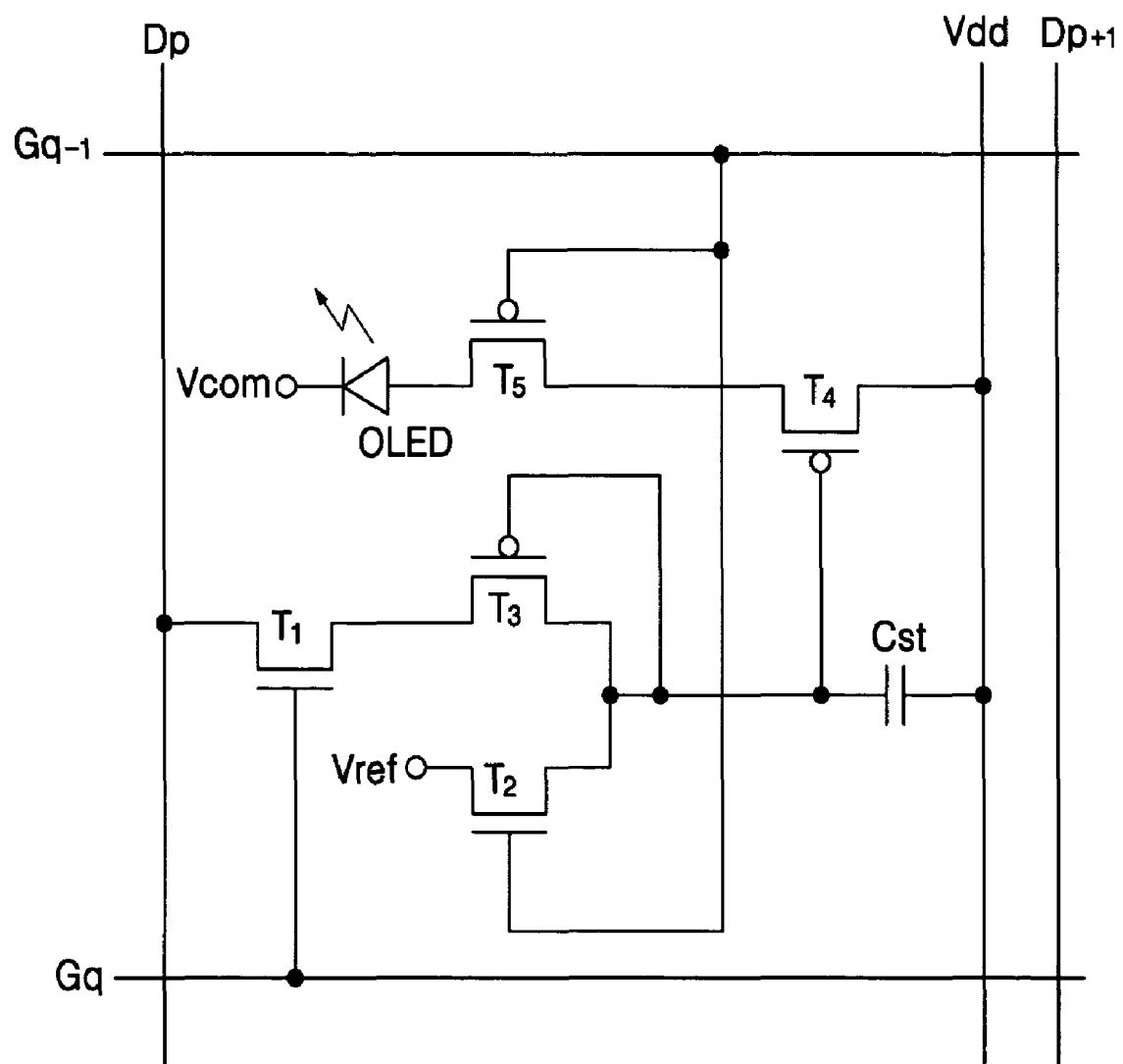


FIG. 4

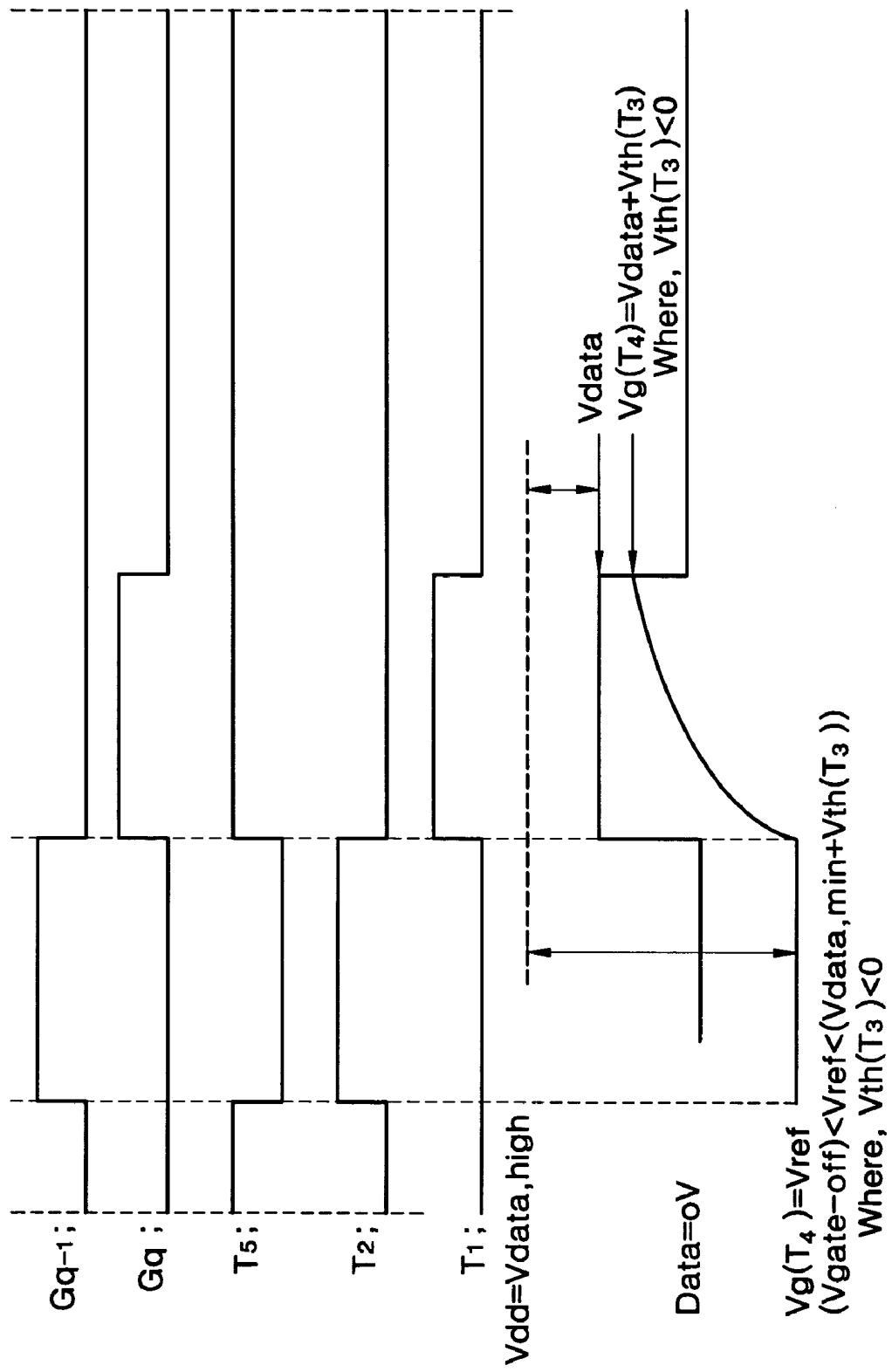


FIG.5A

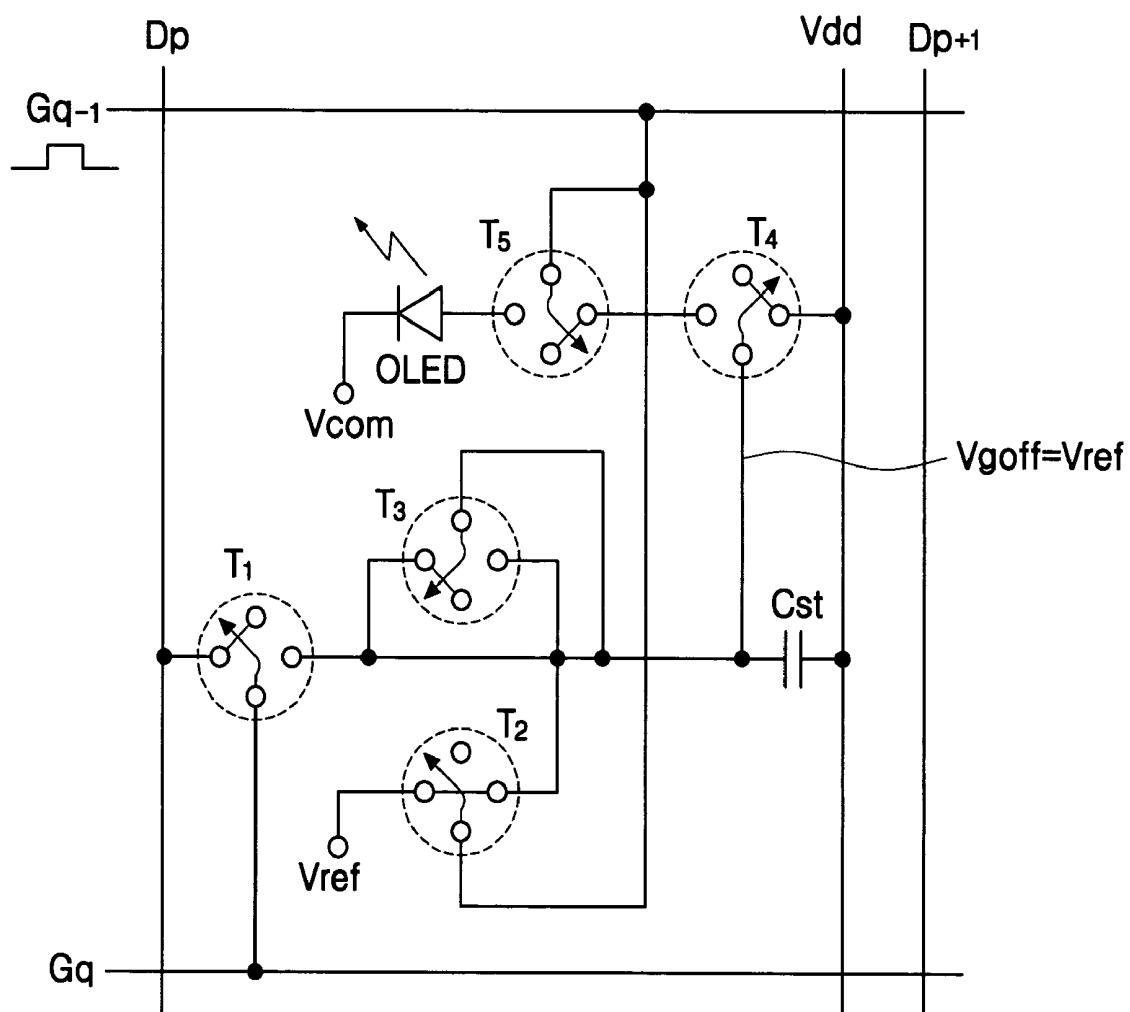


FIG.5B

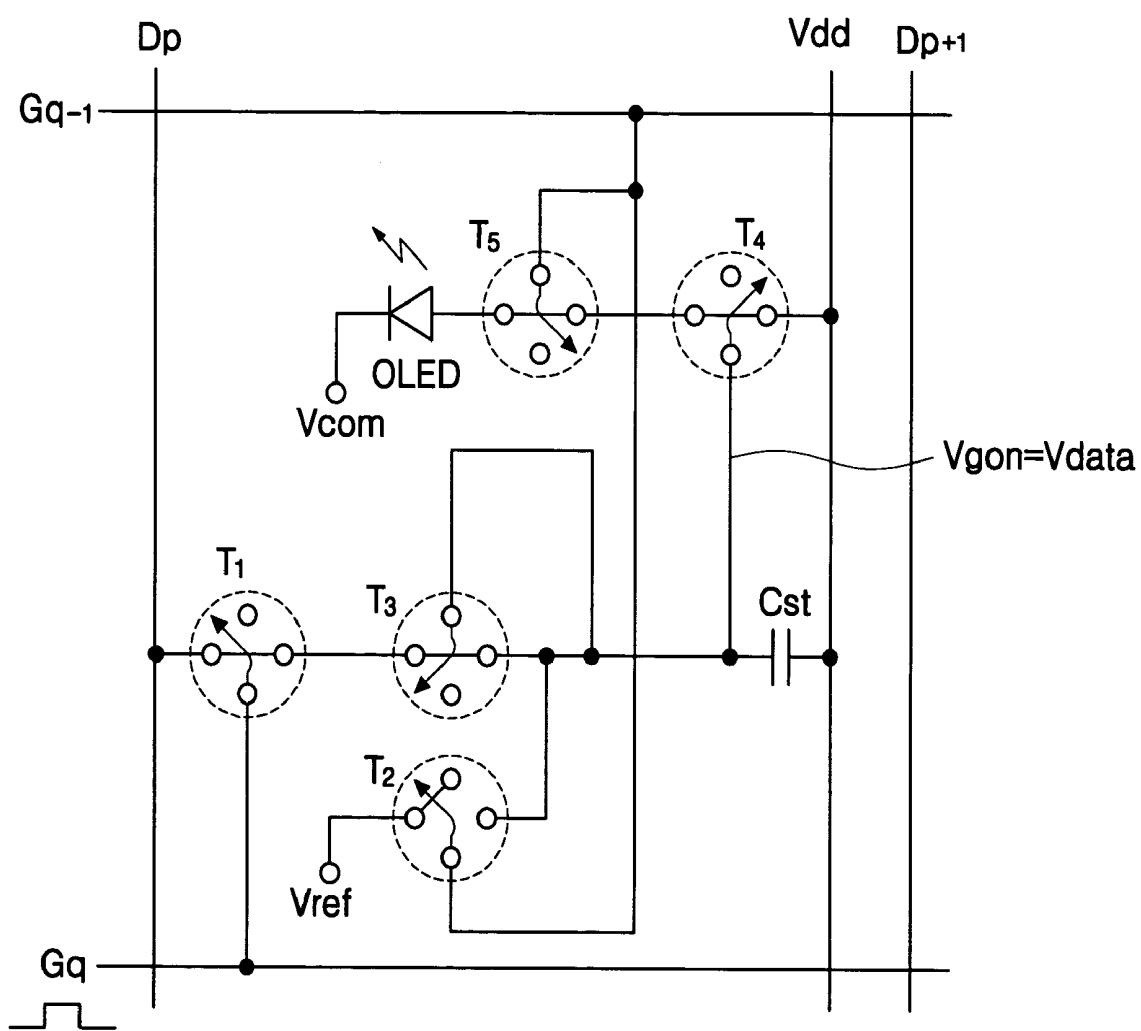


FIG.6

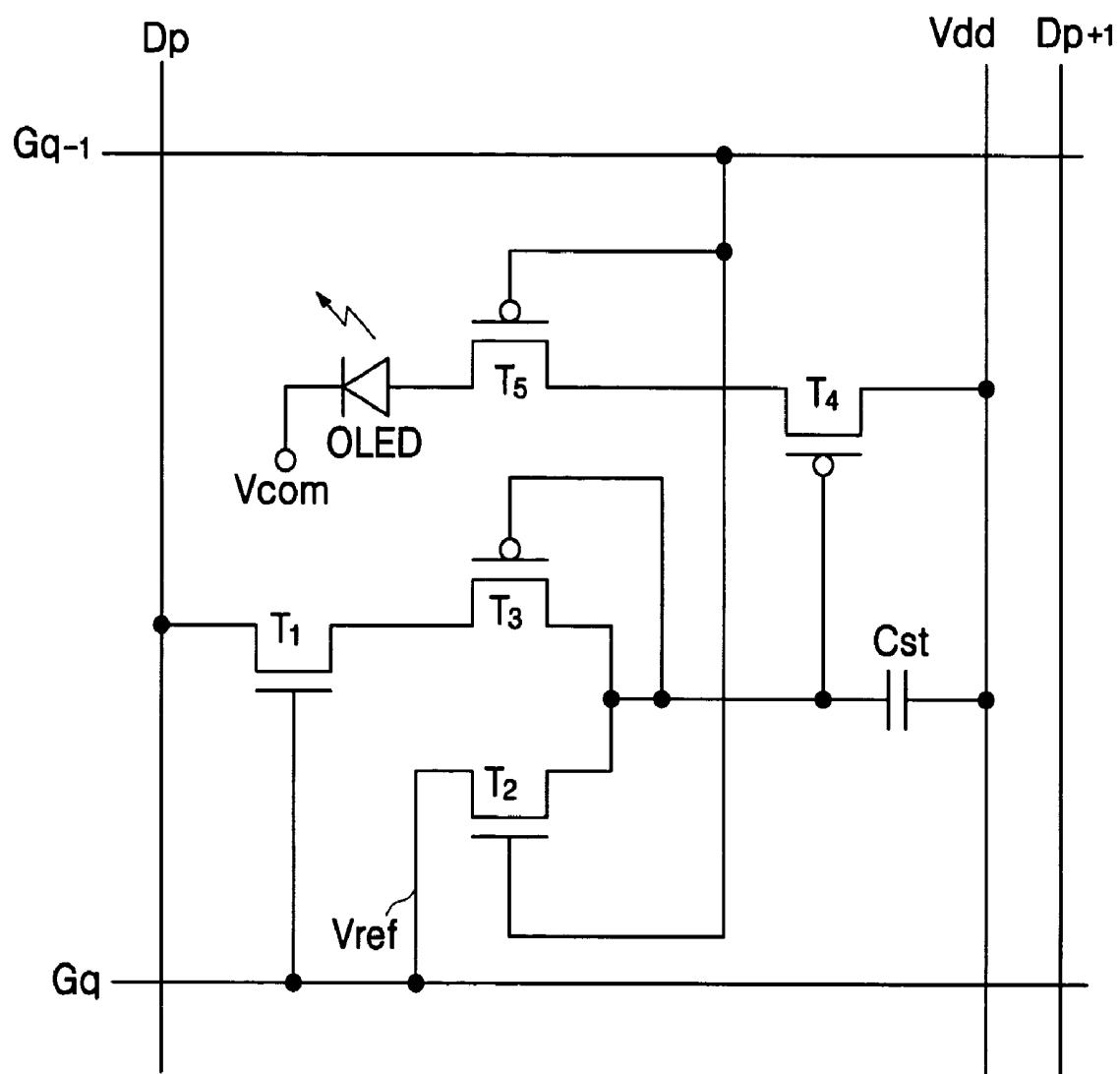


FIG.7

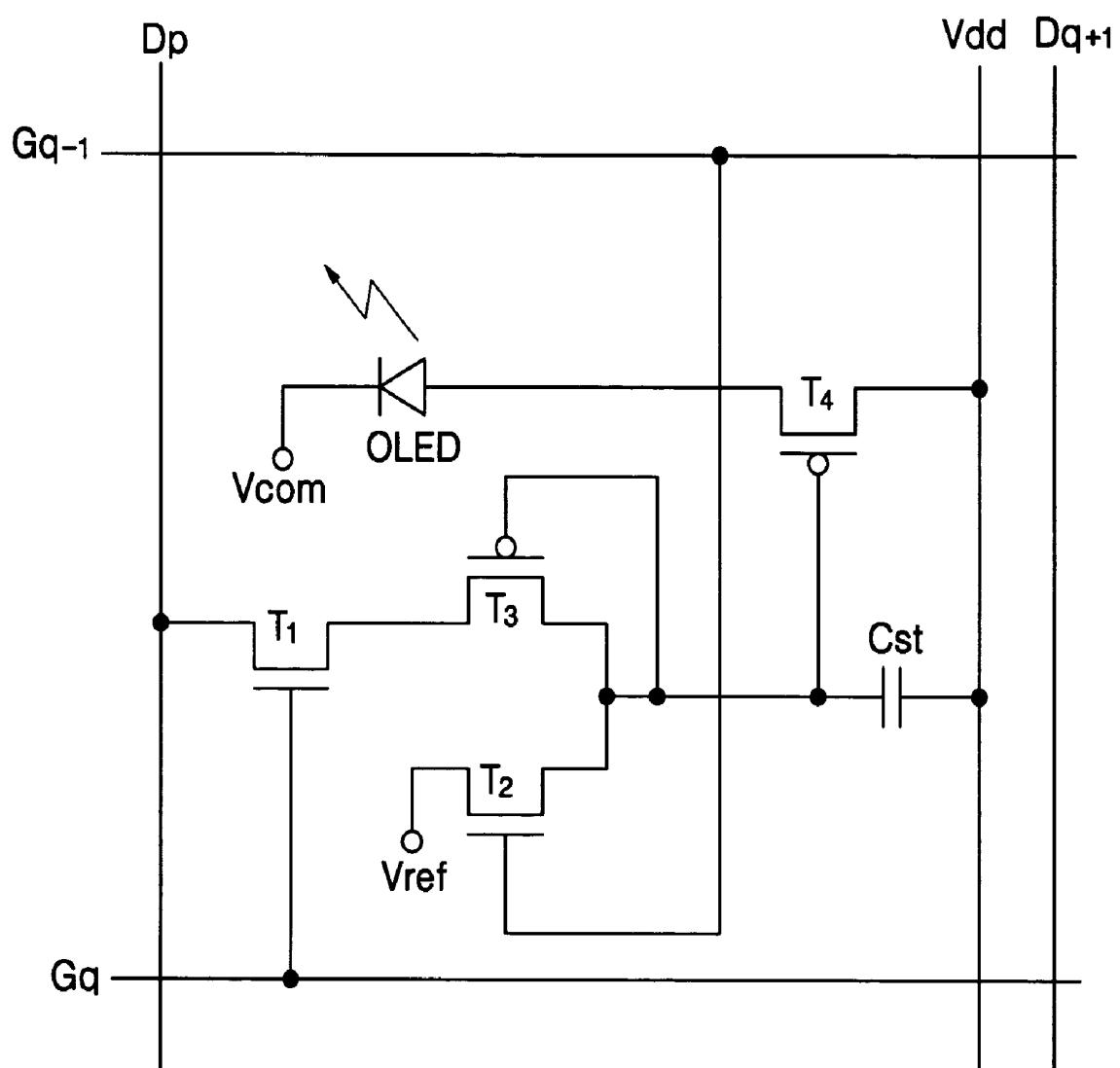


FIG.8

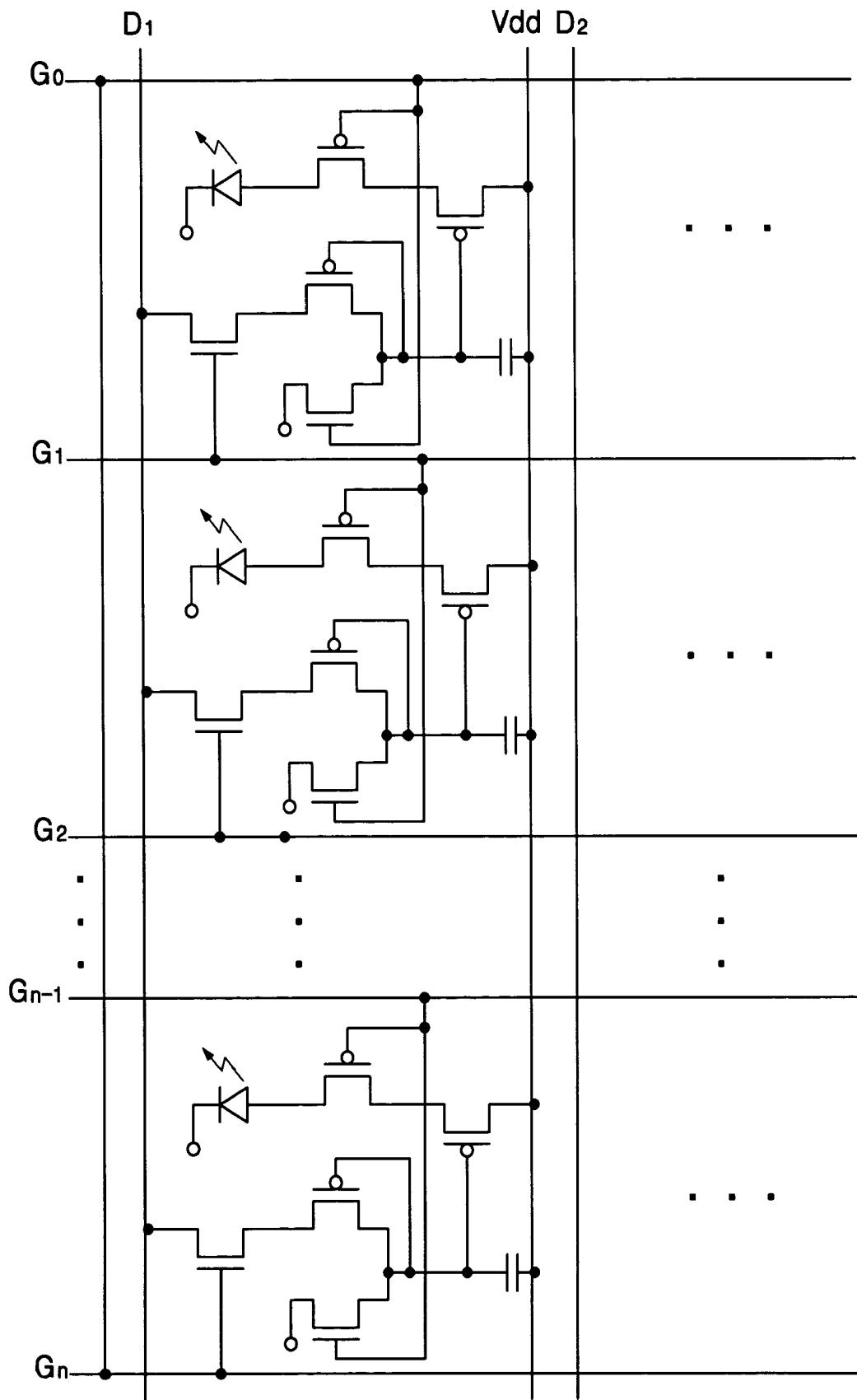


FIG.9

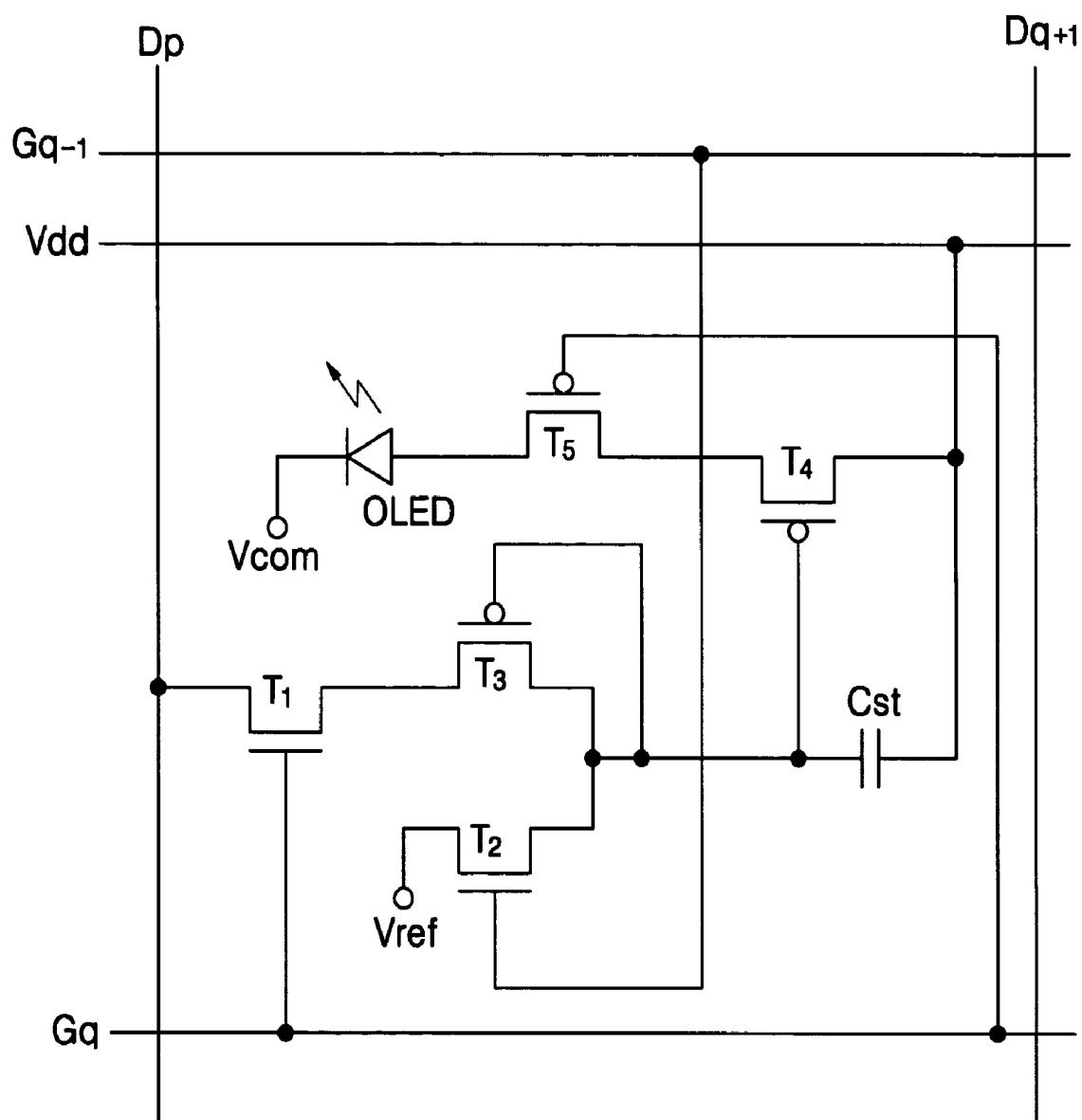


FIG.10

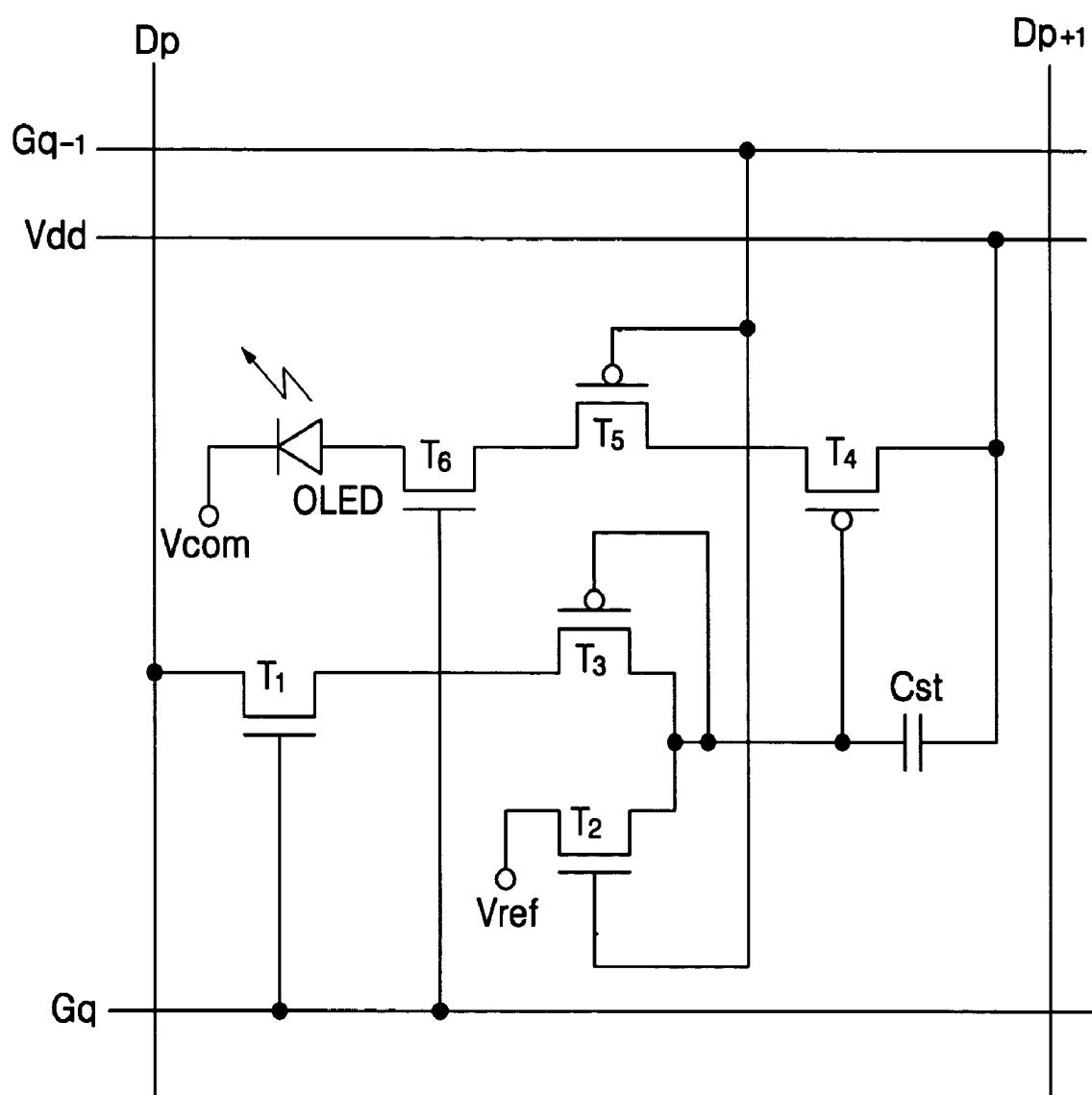


FIG.11

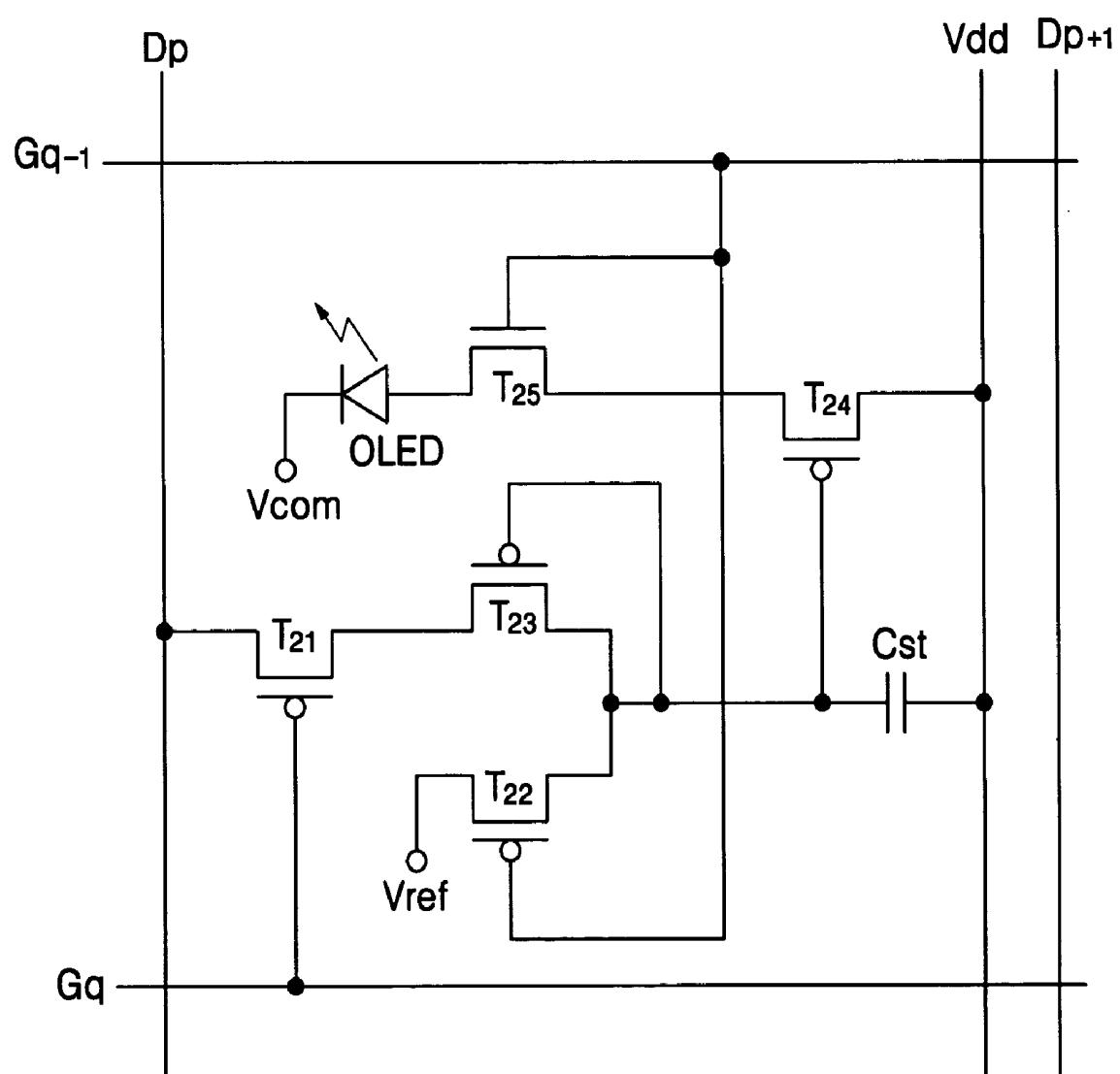


FIG.12

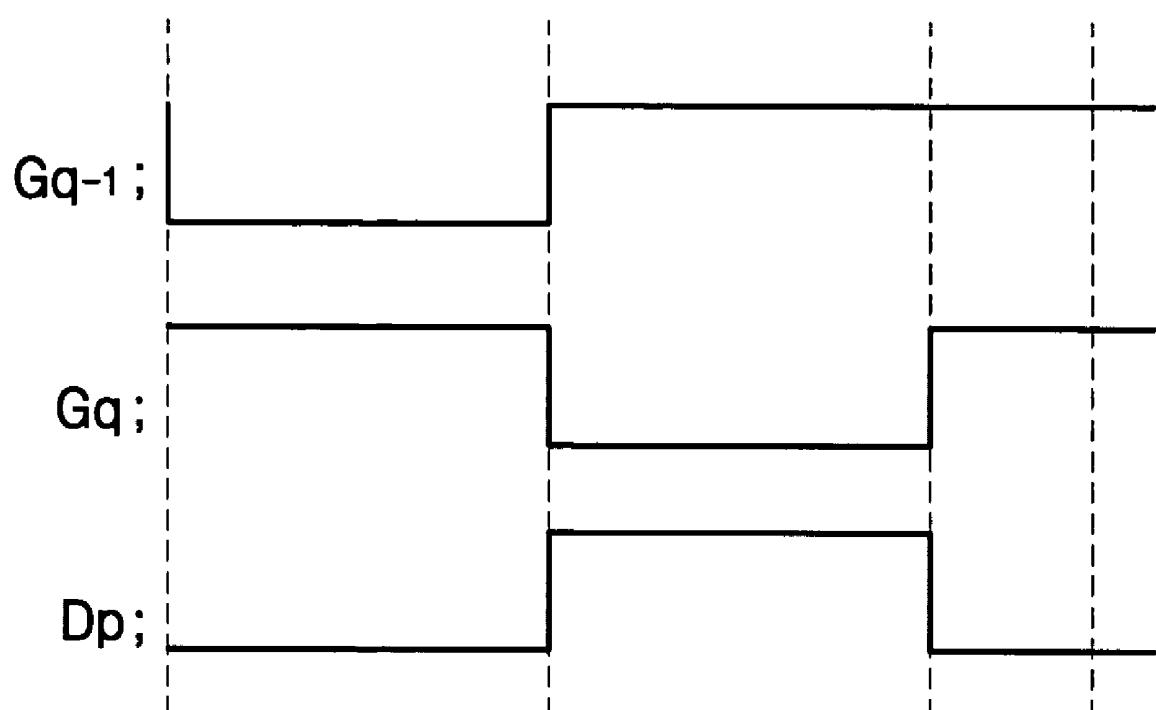


FIG.13A

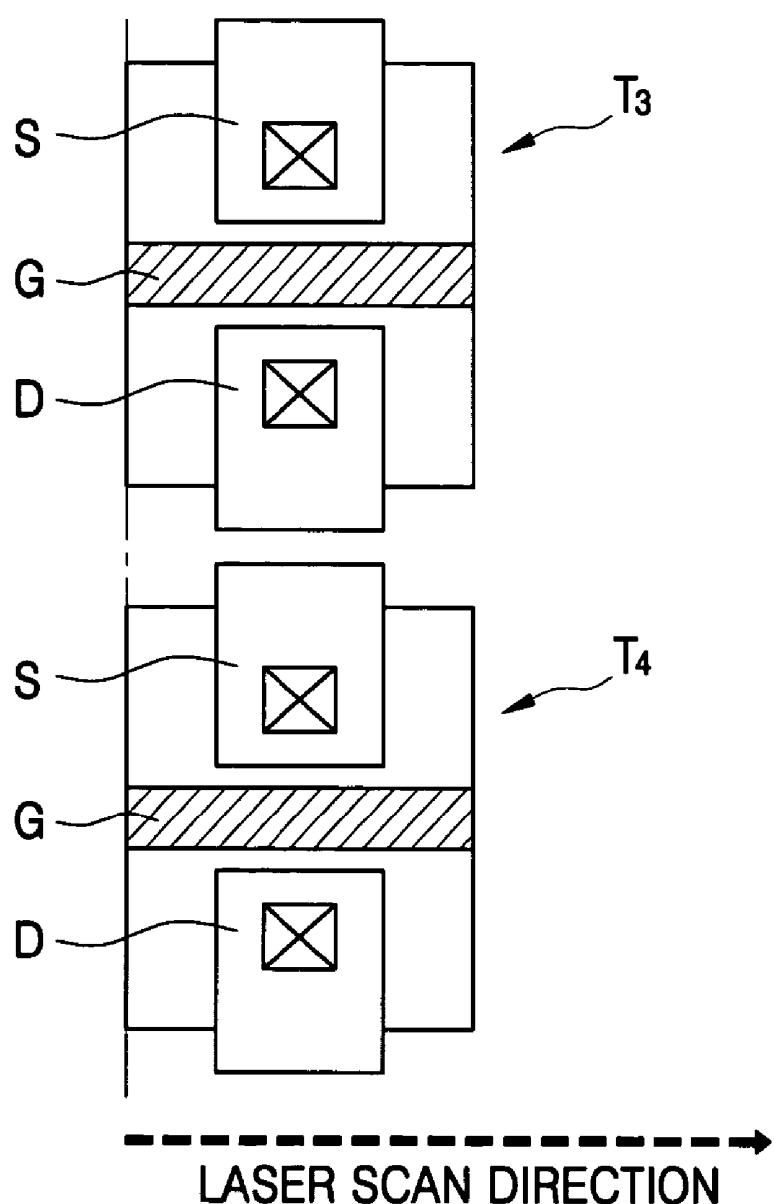


FIG.13B

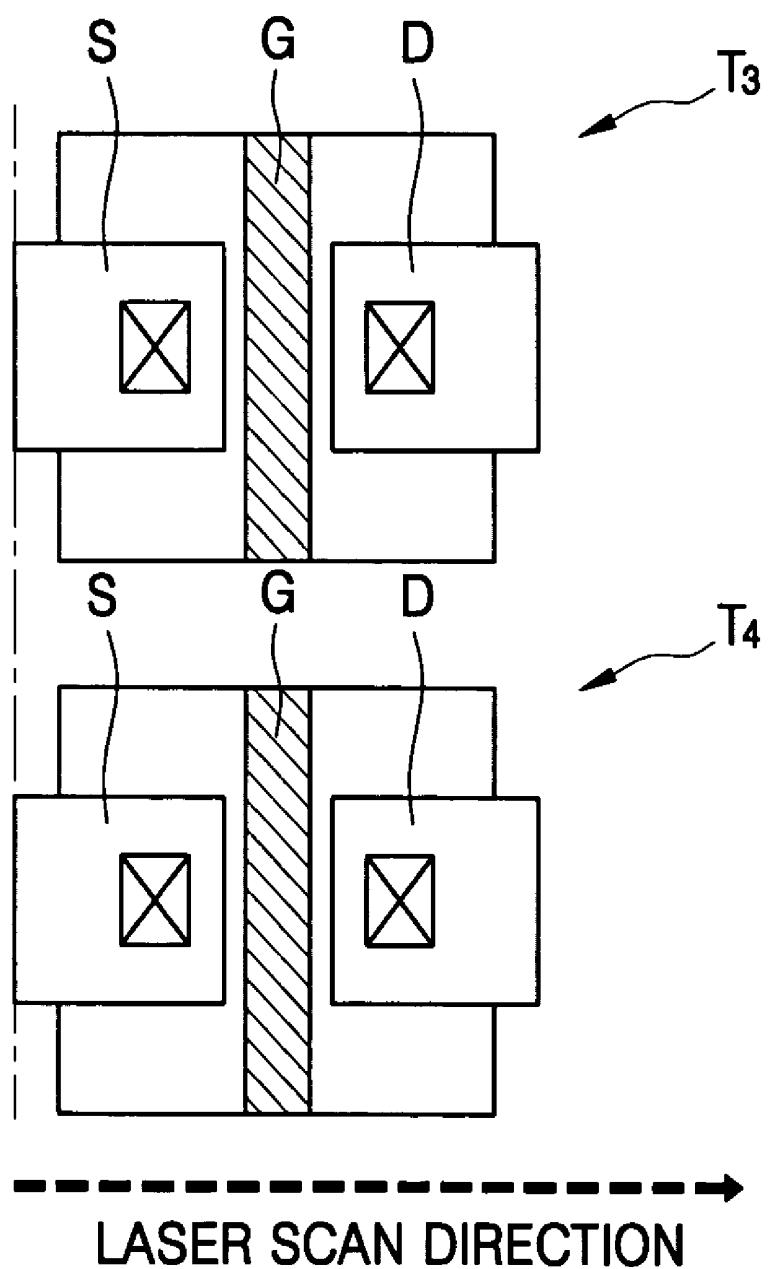


FIG.14

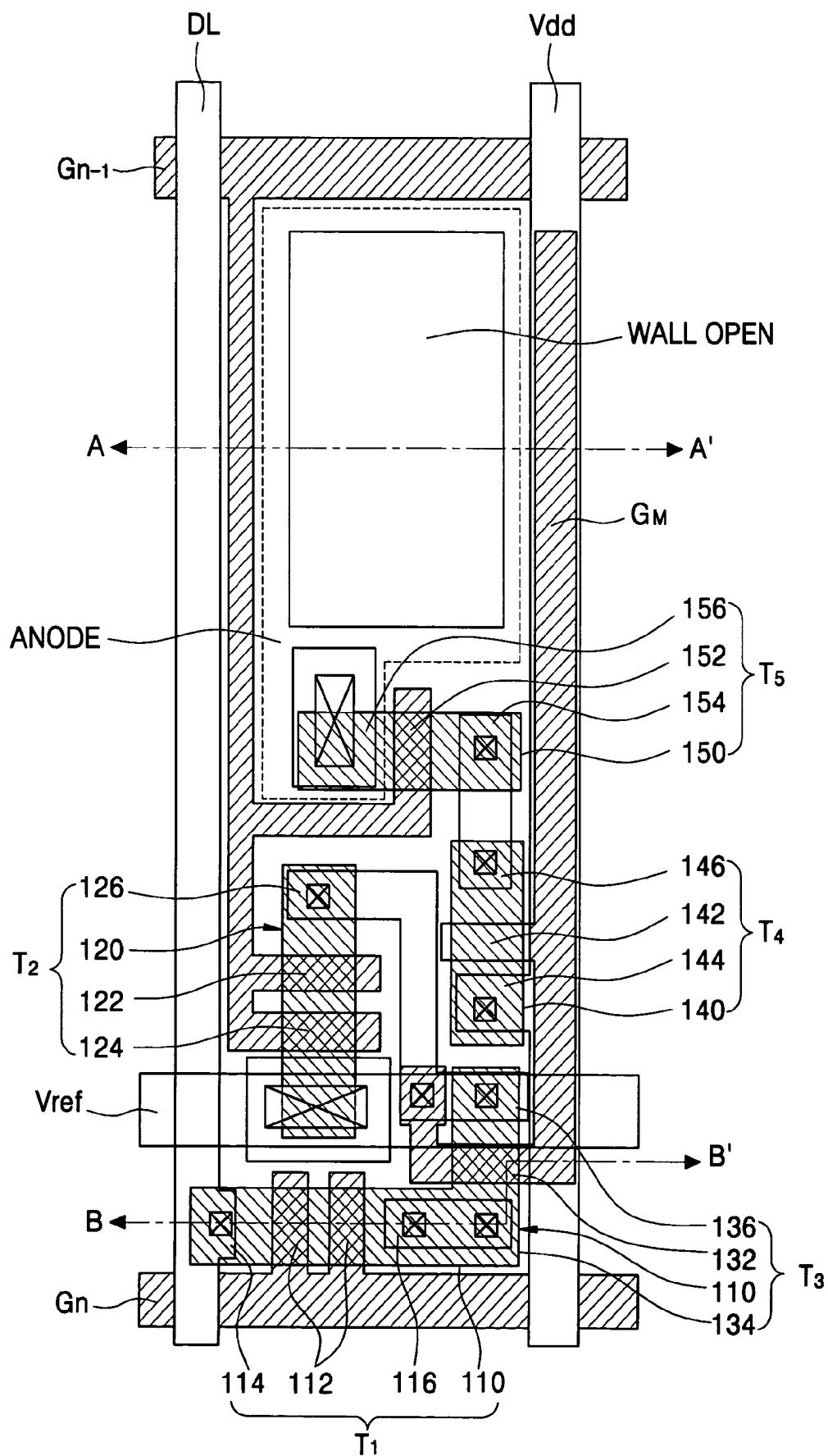


FIG. 15

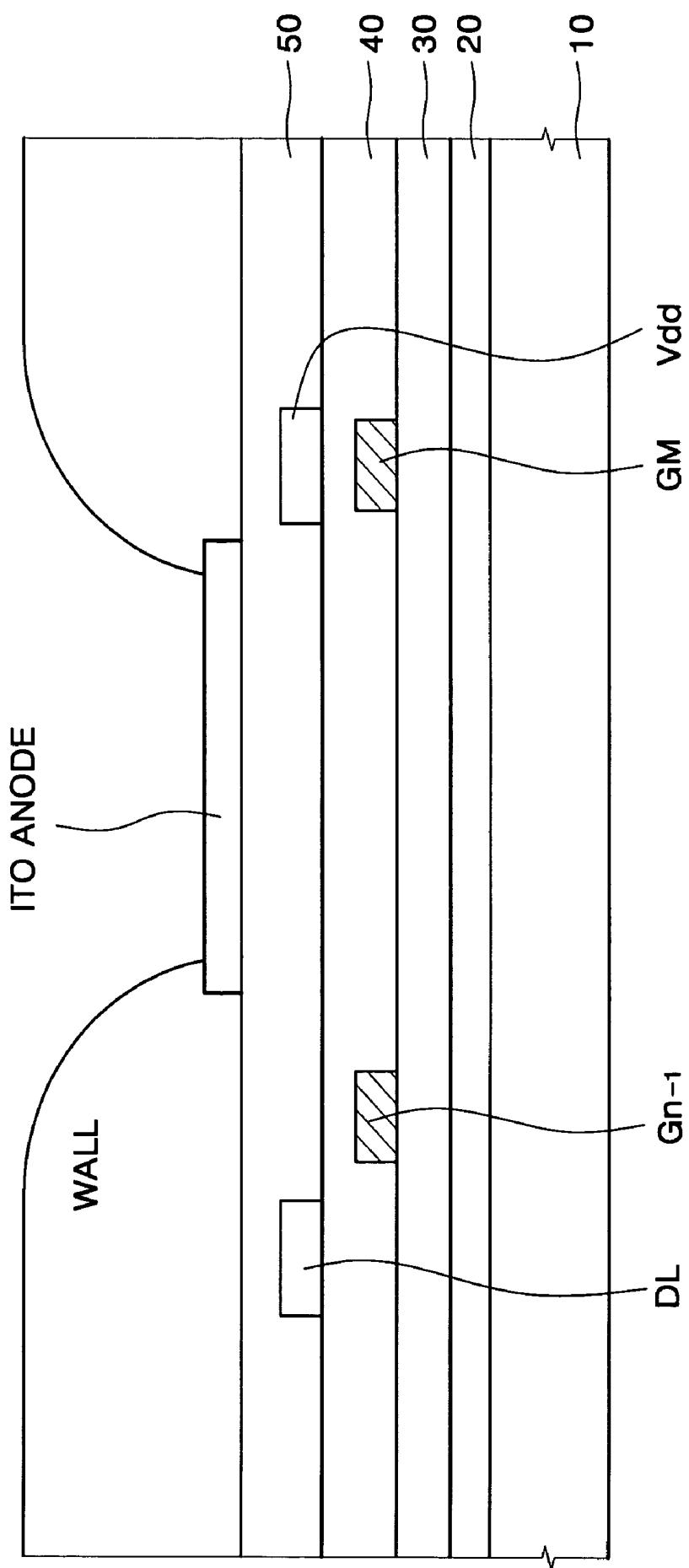
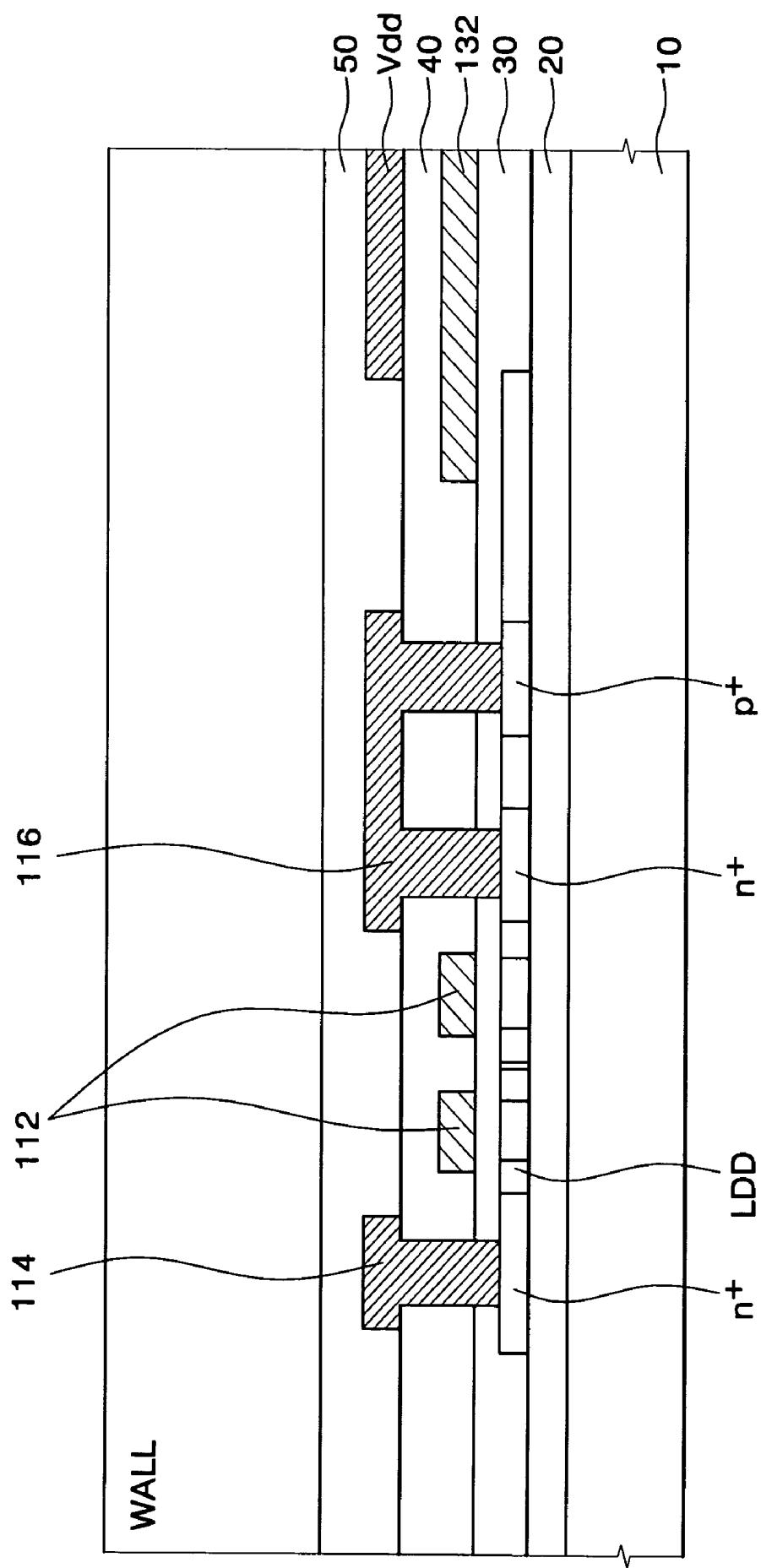


FIG.16



**ORGANIC LIGHT EMITTING DISPLAY
DEVICE AND METHOD OF FABRICATING
THE SAME**

BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention relates to an organic light emitting display device, and more particularly, to a device for driving pixels of an organic light emitting display device and a method of fabricating the same.

2. Description of the Related Art

Cathode ray tube (CRT) devices have been widely used for various kinds of image display devices. Recently, liquid crystal display (LCD) devices have emerged as an alternative display means for, especially, portable equipments, computer monitors, etc. However, CRT devices are generally heavy and have a big size, and LCD devices also have some unsatisfactory factors such as mediocre brightness, low efficiency, etc. In addition, LCD devices have such a drawback that images may have poor views at the side of an LCD device.

Thus, there have been made various developments for an image display device, as a new generation display means, having a lighter weight, a slimmer size, an affordable price, better efficiency, etc. One of such new generation display devices is an organic light emitting display (OLED) device. The OLED devices utilize the electroluminescence characteristics of certain organic compounds or high polymers, which emit light in response to electric current applied thereto. In the OLED devices, no backlight device is necessary for providing light to a display panel, which is required for the LCD devices. Thus, the OLED devices advantageously have a lighter weight, a smaller (and slimmer) size, a lower cost, etc. and are more readily fabricated compared with the LCD devices. In addition, the OLED devices may have superior brightness and a larger viewing angle.

FIG. 1 is a circuit diagram illustrating a conventional driving circuit for an OLED device, and FIG. 2 is a graphical view of signal waveforms applied to the driving circuit in FIG. 1. Referring to FIGS. 1 and 2, the conventional driving circuit for an OLED device includes a switching transistor Q_S having a gate and a source connected to a gate line Gq and a data line D_p , respectively, a storage capacitor Cst having one terminal connected to a drain of the switching transistor Q_S and the other terminal connected to a bias voltage V_{dd} , and a driving transistor Q_D having a gate connected to the drain of the switching transistor Q_S and a source connected to the bias voltage V_{dd} .

A driving signal is provided from a drain of the driving transistor Q_D to an organic light emitting diode OLED. The organic light emitting diode OLED has one end connected to a drain of the driving transistor Q_D and the other end connected to a common electrode voltage V_{COM} . Generally, the switching transistor Q_S is an N-type thin film transistor that is turned on by applying a high-level voltage signal to its gate, and the driving transistor Q_D is a P-type thin film transistor that is turned-off when the high-level voltage signal is applied to its gate.

In the operation the driving circuit in FIG. 1, when the switching transistor Q_S is turned on by a gate signal provided through the gate line Gq , a data signal from the data line D_p is transferred through the conduction path of the switching transistor Q_S to the gate of the driving transistor Q_D as a gate voltage. The gate voltage is maintained for one frame due to the storage capacitor Cst . At this time, channel conductance

of the driving transistor Q_D is determined by the gate voltage applied to the gate and the bias voltage applied to the source of the driving transistor Q_D . Also, the intensity of a voltage applied between the ends of the organic light emitting diode OLED is determined based on a voltage distribution of the organic light emitting diode OLED with respect to the voltage between the bias voltage V_{dd} and the common electrode voltage V_{COM} , where the organic light emitting diode OLED and the driving transistor Q_D are connected each other in series. The organic light emitting diode OLED emits light in response to current flowing therein, which is corresponding to the intensity of the voltage determined based on the voltage distribution.

Thus, even if the same data signal is applied to the gate of the driving transistor Q_D so that the gate-source voltage V_{GS} of the driving transistor Q_D has an identically value in different driving circuits for different pixels of the OLED device, the voltage distribution may vary depending on characteristics of the driving transistor Q_D in different pixels so that the intensity of the voltage between the ends of organic light emitting diode may vary as well. As a result, the current flowing the organic light emitting diode OLED may be different in different pixels of the OLED device. Such variation in the current flowing the organic light emitting diode OLED may cause deterioration in brightness of pixels and display quality of the OLED device.

Therefore, it is desired that the driving circuit of an OLED device is improved so that every organic light emitting diode in the respective pixels of the OLED device receives the same driving current in response to the same data signal so as to emit the same amount of light.

BRIEF SUMMARY OF THE INVENTION

The present invention provides a pixel driving unit for an OLED device that compensates for characteristics of a driving thin film transistor in the pixel driving unit to improve the display quality of the OLED device. The present invention also provides a method of fabricating such a pixel driving unit for an OLED device.

In one aspect of the invention, a pixel driving unit for providing a driving signal to an organic light emitting diode in an OLED device includes first and second control lines for transferring previous and current control signals, respectively, in a sequential process for providing the driving signal to the organic light emitting diode, a data line for transferring a data signal for displaying images on the image display device, a first switching device including a conduction path for transferring the data signal from the data line, the conduction path of the first switching device being controlled by the current control signal from the second control line, a second switching device including a conduction path for transferring a reference signal externally supplied, the conduction path of the second switching device being controlled by the previous control signal from the first control line, a third switching device including a conduction path for transferring the data signal provided from the first switching device, the conduction path of the third switching device being controlled by a state of the second switching device, and a fourth switching device including a conduction path for receiving a bias voltage and generating the driving signal to the organic light emitting diode, the conduction path of the fourth switching device being controlled by one of the reference signal from the second switching device and the data signal from the third switching device.

In the pixel driving unit, the third and fourth switching devices may have switching characteristics substantially

identical to each other. Also, a capacitor may be included for being charged with the bias voltage and for providing a voltage signal to control the conduction path of the third switching device. The first, second, third and fourth switching devices may be first, second, third and fourth thin film transistors, respectively, each having a conduction path between a source and a drain and a gate for receiving a control signal to control the conduction path. The first and second control signal lines may be first and second gate lines, respectively, and the previous and current control signals may be previous and current gate signals, respectively.

In another aspect of the present invention, an organic light emitting display device includes gate lines to which an active gate line is sequentially supplied, data lines to which data signals are applied to display images on the organic light emitting display device and pixel driving units each of which provides a driving signal to a corresponding OLED diode in association with a pair of the gate lines and a pair of the data lines, in which each of the pixel driving units has a driving transistor having a conduction path with one terminal receiving a bias voltage and the other terminal providing the driving signal to the diode, a first switching transistor having a conduction path for transferring a reference signal, the conduction path of the first switching transistor being controlled by a previous gate signal, and a second switching transistor having a conduction path for transferring a data signal, the conduction path of the second switching transistor being controlled by a state of the first switching transistor. The conduction path of the driving transistor may be controlled by one of the reference signal from the first switching transistor and the data signal from second switching transistor. The gate lines may include a dummy gate line for providing a gate signal to the first switching transistor of a first one of the pixel driving units.

In another aspect of the present invention, there is provided a method for fabricating a semiconductor device for providing a pixel driving signal in an organic light emitting display device. The method includes providing an insulation substrate, forming on the insulation substrate a first amorphous silicon thin film transistor for providing the pixel driving signal to an organic light emitting diode, forming on the insulation substrate a second amorphous silicon thin film transistor for transferring a data signal to control a switching function of the first amorphous silicon thin film transistor, crystallizing the first and second amorphous silicon thin film transistors by performing a laser scan on the first and second amorphous silicon thin film transistor, and transforming the first and second amorphous silicon thin film transistor into first and second polysilicon thin film transistors, respectively, by consummating the crystallizing step. The first and second polysilicon thin film transistors may have characteristics substantially identical to each other.

These and other objects, features and advantages of the present invention will become apparent from the following detailed description of the exemplary embodiments thereof, which is to be read in conjunction with the accompanying drawings, wherein like elements are designated by identical reference numbers throughout the several views.

BRIEF DESCRIPTION OF THE DRAWINGS

The above and other advantages of the present invention will become readily apparent by reference to the following detailed description when considered in conjunction with the accompanying drawings wherein:

FIG. 1 is a circuit diagram illustrating a conventional driving circuit for an OLED device;

FIG. 2 is a graphical view of signal waveforms applied to the driving circuit in FIG. 1;

5 FIG. 3 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a first embodiment of the present invention;

FIG. 4 is a graphical view of signal waveforms applied to the pixel driving unit in FIG. 3;

10 FIGS. 5A and 5B are schematic diagrams for describing the operation of the pixel driving unit in FIG. 3;

FIG. 6 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a second embodiment of the present invention;

15 FIG. 7 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a third embodiment of the present invention;

FIG. 8 is a circuit diagram illustrating multiple pixel driving units of an OLED device arranged in association with gate and data lines according to an embodiment of the present invention;

20 FIG. 9 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a fourth embodiment of the present invention;

FIG. 10 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a fifth embodiment of the present invention;

25 FIG. 11 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a sixth embodiment of the present invention;

FIG. 12 is a graphical view of signal waveforms applied to the pixel driving unit in FIG. 11;

30 FIGS. 13A and 13B are schematic diagrams each illustrating two thin film transistors fabricated according to an exemplary embodiment of the present invention;

FIG. 14 is a plan view of the pixel driving unit in FIG. 3; and

35 FIGS. 15 and 16 are cross-sectional views of the pixel driving unit taken along lines A-A' and B-B', respectively, in FIG. 14.

DETAILED DESCRIPTION OF THE INVENTION

45 Detailed illustrative embodiments of the present invention are disclosed herein. However, specific structural and functional details disclosed herein are merely representative for purposes of describing exemplary embodiments of the present invention.

50 FIG. 3 is a diagram illustrating a pixel driving unit of an organic light emitting display (OLED) device according to a first exemplary embodiment of the present invention, and FIG. 4 is a graphical view of signal waveforms applied to the pixel driving unit in FIG. 3.

55 In FIG. 3, the pixel driving unit of an OLED device includes five transistors, for example, first to third thin film transistors T₁-T₃ each having a switching function and fourth and fifth thin film transistors T₄, T₅ each having a driving function. The pixel driving unit also includes a storage capacitor Cst for storing electric charge and an OLED diode for emitting light in response to a driving signal applied from the fifth thin film transistor T₅. The OLED diode has a first terminal receiving the driving signal from the fifth transistor T₅ and a second terminal connected to a common electrode voltage V_{COM}. In this embodiment, the five thin film transistors T₁-T₅, the storage capacitor Cst,

and the OLED diode are the elements mainly constituting the pixel driving unit for a unit pixel of an OLED device.

The pixel driving units are arranged in association with gate lines and data lines of the OLED device such that each pixel driving unit is disposed in a region surrounded by adjacent gate lines and adjacent data lines. Power supply lines each providing a bias voltage Vdd for the OLED device is also arranged such that each power supply line is parallel with a corresponding data line D_{p+1}. A selected number of the pixel driving units of the OLED device are connected to the power supply line Vdd, and the number of the pixel driving units is equal to the number of the gate lines. The power supply line Vdd may be formed as a single metal layer (e.g., MoW layer) or dual metal layers (e.g., MoW layer and AlNd layer).

As shown in FIG. 3, one pixel driving unit (or one unit pixel) is defined by p_{th} and (p+1)_{th} data lines and (q-1)_{th} and q_{th} gate lines in an OLED device having a resolution of mxnx3. In the pixel driving unit, for example, the first and second thin film transistors T₁, T₂ are N-type transistors, which are each turned on when a gate signal higher than the threshold voltage of a corresponding transistor is applied to its gate. The third to fifth thin film transistors T₃-T₅ are P-type transistors, which are each turned on when a gate signal lower than the threshold voltage of a corresponding transistor is applied to its gate. In particular, the first thin film transistor T₁ has a gate connected to a present gate line G_q and a source connected to a data line D_p. The first thin film transistor T₁ transmits a data signal, which is inputted through the source, to the third thin film transistor T₃ through the drain thereof in response to the gate signal applied through the present gate line G_q.

The second thin film transistor T₂ has a gate connected to a previous gate line G_{q-1} and a source connected to a reference voltage line to which a reference voltage V_{ref} is supplied. The second thin film transistor T₂ transmits the reference voltage V_{ref} which is inputted through the source, to the fourth thin film transistor T₄ through the drain thereof in response to the gate signal applied through the previous gate line G_{q-1}. In other words, the second thin film transistor T₂ has a conduction path between the reference voltage V_{ref} and the gate of the fourth thin film transistor T₄, and the conduction path is controlled by the gate signal applied from the previous gate line.

The third thin film transistor T₃ has a source connected to the drain of the first thin film transistor T₁, and a gate and a drain commonly connected to the drain of the second thin film transistor, the storage capacitor Cst and the gate of the fourth thin film transistor T₄. The third thin film transistor T₃ transmits the data signal transferred through the first thin film transistor T₁ to the fourth thin film transistor T₄ as a gate control signal of the fourth thin film transistor T₄. In other words, the third thin film transistor T₃ has a conduction path to transfer the data signal from the data line D_p to the gate of the driving transistor, i.e., the fourth thin film transistor T₄. The conduction path of the third thin film transistor T₃ is controlled by a state of the second thin film transistor T₂. In other words, the third thin film transistor T₃ is turned on when the second thin film transistor T₂ is turned off. The second and third thin film transistors are parallel to each other with respect to the fourth thin film transistor, and provide the reference voltage and the data signal, respectively, to the gate of the fourth thin film transistor.

The fourth thin film transistor T₄ has a source connected to the power supply line for supplying the bias voltage Vdd. The gate of the fourth thin film transistor T₄ is connected in common to one terminal of the storage capacitor Cst, the

drain of the second thin film transistor, and the drain of the third thin film transistor T₃. The fourth thin film transistor T₄ has a conduction path to transfer the bias voltage Vdd to the fifth thin film transistor T₅, and the conduction path is controlled by a gate signal, either the reference signal from the second thin film transistor T₂ or the data signal from the third thin film transistor T₃. The fourth thin film transistor T₄ has characteristics similar or substantially identical to that of the third thin film transistor T₃.

The fifth thin film transistor T₅ has a source connected to a drain of the fourth thin film transistor T₄, a drain connected to the OLED diode, and a gate connected to the previous gate line G_{q-1}. The fifth thin film transistor T₅ outputs the driving signal (e.g., the bias voltage V_{dd}) provided from the fourth thin film transistor T₄ to the OLED diode in response to a gate signal applied through the previous gate line G_{q-1}. In other words, the fifth thin film transistor T₅ has a conduction path controlled by the previous gate signal to provide the driving signal to the OLED diode. The OLED diode emits light in response to the driving signal. The OLED diode has two terminals, one connected to the drain of the fifth thin film transistor and the other connected to the common electrode voltage V_{COM}.

The storage capacitor Cst has two terminals, one commonly connected to the drains of the second and third transistors and the gates of the third and fourth transistors T₃, T₄ and the other connected to the bias voltage Vdd. The storage capacitor Cst is charged with the bias voltage Vdd and supplies a high-level signal (e.g., the bias voltage V_{dd}) to the second through fourth thin film transistors T₂-T₄ for one frame. When the previous gate line G_{q-1} has a logic-high signal, the second transistor T₂ is turned on so that the voltage stored in the storage capacitor Cst is discharged through the second transistor of which source electrode a reference signal Vref of logic-low is applied to. As a result, the reference signal Vref is applied to the gate of the fourth transistor T₄.

Hereinafter, a further detail description of the operation of the switching and driving transistors of the pixel driving unit in FIG. 3 follows. FIGS. 5A and 5B are schematic diagrams for describing the operation of the pixel driving unit of an OLED device in FIG. 3. The operation status of the thin film transistors T₁-T₅ of the pixel driving unit is shown in FIG. 5A when an active gate signal is applied to the previous gate line, and also in FIG. 5B when an active gate signal is applied to the present gate line.

Referring to FIG. 5A, when an active gate signal (e.g., a high level pulse signal) is applied to the previous gate line, the first, third, fourth and fifth thin film transistors T₁, T₃, T₄, T₅ are turned off and the second thin film transistor T₂ is turned on. As a result, the reference voltage V_{ref} supplied from the reference voltage line is applied to the gate of the fourth thin film transistor T₄. The reference voltage V_{ref} may be defined as following Equation 1.

$$[V_{gate-off(T1)}] \leq V_{ref} \leq [V_{data,min} + V_{th(T3)}] \quad \text{Equation 1}$$

Here, V_{gate-off(T1)} is a gate-off voltage of the first thin film transistor T₁, V_{data,min} is the minimum voltage value of a data signal applied to the data line D_p, and V_{th(T3)} is a threshold voltage of the third thin film transistor T₃, which is a negative voltage. In this condition, the gate-off voltage of the fourth thin film transistor T₄ becomes the reference voltage Vref, and the gate-off voltage of the third thin film transistor T₃ also becomes the reference voltage Vref.

Referring to FIG. 5B, when an active gate signal (e.g., a high level pulse signal) is applied to the present gate line, the

first thin film transistor T_1 is turned on and the second thin film transistor T_2 is turned off. As a result, a data signal applied from the data line is transferred to the third thin film transistor T_3 through the conduction path of the first thin film transistor. The storage capacitor Cst charged with the data signal voltage V_{data} provides a high-level voltage to the gate of the third thin film transistor T_3 . Then, the third thin film transistor T_3 is turned on and the data signal provided from the first thin film transistor T_3 is transferred to the gate of the fourth thin film transistor T_4 . At this time, an effective gate-source voltage $V_{gs'}^{(T4)}$, which determines the intensity of current flowing the conduction path of the fourth thin film transistor T_4 , is defined as following Equation 2.

$$V_{gs'}^{(T4)} = V_{gs(T4)} + V_{th(T4)} \quad \text{Equation 2}$$

Here, the gate-source voltage $V_{gs(T4)}$ of the fourth thin film transistor T_4 is the difference between a gate voltage of the fourth thin film transistor T_4 and the bias voltage Vdd , as expressed in following Equation 3.

$$V_{gs(T4)} = V_{g(T4)} - V_{dd} \quad \text{Equation 3}$$

Here, the gate voltage $V_{g(T4)}$ of the fourth thin film transistor T_4 is the difference between a data voltage (i.e., a voltage value of the data signal) and a threshold voltage Vth of the third thin film transistor T_3 , as expressed in following Equation 4.

$$V_{g(T4)} = V_{data} + V_{th(T3)} \quad \text{Equation 4}$$

Here, the threshold voltage $V_{th(T3)}$ of the third thin film transistor T_3 is a negative voltage. Assuming that the characteristics of the third and fourth thin film transistors T_3, T_4 are substantially identical to each other, the threshold voltage Vth of the third thin film transistor T_3 is substantially identical to that of the fourth thin film transistor T_4 .

$$V_{th(T3)} = V_{th(T4)} \quad \text{Equation 5}$$

From Equations 2 to 5, the effective gate-source voltage $V_{gs'}^{(T4)}$, determining the intensity of current flowing the fourth thin film transistor T_4 is obtained as follows:

$$V_{gs'}^{(T4)} = V_{data} - V_{dd} \quad \text{Equation 6}$$

As shown in Equation 6, the effective gate-source voltage $V_{gs'}^{(T4)}$ of the fourth thin film transistor T_4 is the difference between the data voltage V_{data} provided through the data line D_p and the bias voltage V_{dd} provided through the external power supply line. Accordingly, the effective gate-source voltage $V_{gs'}^{(T4)}$ of the fourth thin film transistor T_4 in every pixel of the OLED device is only dependent on intensities of the data voltage V_{data} applied through the data line D_p and the bias voltage V_{dd} applied through the external power supply line. In other words, the effective gate-source voltage $V_{gs'}^{(T4)}$ of the driving transistor, which determines the intensity of current flowing the driving transistor, is independent of the threshold voltage Vth of the driving transistor (i.e., the fourth thin film transistor T_4).

Therefore, by employing in each pixel driving unit of the OLED device the third and fourth thin film transistors T_3, T_4 having the substantially same characteristics, the pixel driving unit compensates for the characteristics (especially, the threshold voltage Vth) of the fourth thin film transistor T_4 , which would be different in different pixels. As a result, the driving transistor of each pixel driving unit provides the OLED diode with current having the substantially same intensity in response to a same data signal even if the driving transistor (e.g., the fourth thin film transistor T_4) of a pixel has a different threshold voltage from that of another pixel.

Referring to FIG. 6, there is provided a pixel driving unit for an OLED device according to a second exemplary embodiment of the present invention. In this embodiment, the pixel driving unit does not require a separate line for providing the reference voltage $Vref$. In the circuit diagram of FIG. 6, the pixel driving unit for an OLED device includes first to third thin film transistors T_1-T_3 each having a switching function, fourth and fifth thin film transistors T_4, T_5 each having a driving function, a storage capacitor Cst , and an OLED diode connected to a common electrode voltage V_{COM} . Each pixel driving unit is aligned in a region surrounded by gate lines for transferring gate signals and data lines for transferring data signals. In FIG. 6, the parts equivalent to those in FIG. 3 are represented with like reference numerals and description thereof is omitted to avoid duplication.

In this embodiment, a gate signal applied through the current gate line G_q serves as the reference voltage $Vref$ for the second thin film transistor T_2 . For example, the drain of the second thin film transistor T_2 is connected to the current gate line G_q in common with the gate of the first thin film transistor T_1 .

In the operation of the pixel driving unit, when an active gate signal (e.g., a high-level pulse signal) is applied to the previous gate line G_{q-1} , the first, third, fourth and fifth thin film transistors T_1, T_3, T_4, T_5 are turned off and the second thin film transistor T_2 is turned on. As a result, the reference voltage $Vref$ is applied to the gate of the fourth thin film transistor T_4 through the second thin film transistor T_2 . Since the reference voltage $Vref$ is a gate signal applied to the present gate line that is inactive when the previous gate line is selected to receive an active gate signal, the reference voltage $Vref$ is an off-level signal.

When an active gate signal is applied to a present gate line G_q , the first thin film transistor T_1 is turned on, so that a data signal (e.g., a high-level voltage signal) applied from the data line D_p to the source of the first thin film transistor T_1 is transferred to the third thin film transistor T_3 through the conduction path of the first thin film transistor T_1 . At this time, the storage capacitor Cst charged with the data signal voltage V_{data} provides a high-level voltage to the gate of the third thin film transistor T_3 to turn on the third thin film transistor T_3 . Then, the data signal transmitted through the first and third thin film transistors T_1, T_3 is supplied to the gate of the fourth thin film transistor T_4 . Therefore, as mentioned above, no separate reference line is necessary in this embodiment.

FIG. 7 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a third exemplary embodiment of the present invention. Referring to FIG. 7, the pixel driving unit includes first to third thin film transistors T_1 to T_3 each having a switching function, a fourth thin film transistors T_4 having a driving function, a storage capacitor Cst , and an OLED diode connected to a common electrode voltage V_{COM} , which constitute a unit pixel of the OLED device. The pixel driving unit is aligned in a region surrounded by adjacent gate lines for transferring gate signals and adjacent data lines for transferring data signals. In FIG. 7, the parts equivalent to those in FIG. 3 are represented with like reference numerals and description thereof is omitted to avoid duplication. In the pixel driving unit of this embodiment, the fifth thin film transistor T_5 is omitted from the pixel driving unit according to the first embodiment of the present invention in FIG. 3.

When an active gate signal is applied to the previous gate line G_{q-1} , the first, third and fourth thin film transistors T_1, T_3, T_4 are turned off and the second thin film transistor T_2

is turned on. As a result, a reference voltage Vref supplied from a reference voltage line to the source of the second thin film transistor T₂ is applied to the gate of the fourth thin film transistor T₄. In this embodiment, the reference voltage Vref is the same as the one described in Equation 1.

Also, when an active gate signal is applied to a present gate line G_q, the first thin film transistor T₁ is turned on so that a data signal applied through the data line D_p to the source of the first thin film transistor T₁ is transferred to the third thin film transistor T₃ through the conduction path of the first thin film transistor T₁. At this time, since the storage capacitor Cst charged with the data signal voltage Vdata provides a high-level voltage to the gate of the third thin film transistor T₃, the third thin film transistor T₃ is turned on. Thus, the data signal passing through the first and third thin film transistors T₁, T₃ is supplied to the gate of the fourth thin film transistor T₄.

In like manner, the pixel driving unit of this embodiment compensates its pixel driving function for any variance in the threshold voltage Vth of the fourth thin film transistor T₄, which would have a characteristic different from that of a fourth thin film transistor in another pixel driving unit of the same OLED device. With such compensation, the pixel driving unit provides the OLED diode with the same current as a driving signal in response to the same data signal independent of the varying characteristics of the driving transistor in different pixel driving units.

FIG. 8 is a circuit diagram illustrating multiple pixel driving units of an OLED device arranged in association with gate and data lines according to an embodiment of the present invention. In this embodiment, the multiple pixel driving units each have the structure identical to that of the embodiment in FIG. 3. Referring to FIG. 8, the OLED device has multiple pixel driving units arranged in a matrix form respectively corresponding to the pixels of the OLED device. The OLED device in this embodiment has "n" pixel driving units (i.e., "n" pixels) in a column and "n" gate lines G₁-G_n each associated with a corresponding one of the "n" pixel driving units. The OLED device sequentially provides a gate signal, as a scanning signal, to the respective gate lines.

In addition to the "n" gate lines G₁, G₂ . . . G_{n-1}, and G_n for the "n" pixel driving units, the OLED device also has a dummy gate line G₀ to supply a gate signal to the gates of the second and fifth thin film transistors T₂ and T₅ of the pixel driving unit in association with the first gate line G₁. The dummy gate line G₀ is synchronized with the n_{th} gate line G_n. By synchronizing the dummy gate line G₀ with the n_{th} gate line G_n, the dummy gate line G₀ is prevented from remaining in a floating state.

Alternatively, the dummy gate line G₀ may receive a separate gate signal from a gate driver instead of being synchronized with the n_{th} gate line G_n. In other words, a gate driver sequentially provides the "n" gate signals to the "n" gate lines, respectively, to drive a selected gate line. When the gate driver provides a gate signal to the n_{th} gate line G_n, it also provides the same gate signal to the dummy gate line G₀ simultaneously. Thus, the dummy gate line G₀ has the same effect as being synchronized with the n_{th} gate line G_n and is prevented from remaining in the floating state.

In the above embodiments of FIGS. 3 to 8, the pixel driving units (or the pixels) of an OLED device are arranged in a matrix form such that each pixel driving unit is defined by the adjacent gate lines expanded in the row direction and arranged parallel with each other in the column direction and the adjacent data lines expanded in the column direction and arranged parallel with each other in the row direction. Also,

a power supply line is expanded in the column direction and arranged parallel with the data lines to provide a bias voltage to a driving transistor of the respective pixel driving units.

In this configuration, such arrangement of the power supply line parallel with the corresponding data line may cause the "cross-talk" phenomenon in the OLED device. In other words, when the power supply line is expanded in the column direction parallel with the data line as shown in FIG. 8, a full-level bias voltage is applied to a first pixel driving unit, but the level of the bias voltage may be gradually lowered as it is applied to lower pixels. As a result, a voltage difference may exist between the gate-source voltage V_{gsl}(T₄) of the fourth thin film transistor T₄ in the first pixel driving unit and the gate-source voltage V_{gsln(T4)} of the fourth thin film transistor T₄ in the n_{th} pixel driving unit. Due to the difference of the gate-source voltage between the pixel driving units, a voltage difference may exist between sources of the fourth thin film transistors in the respective pixel driving units, even if data voltage having the same level is applied to the pixel driving units. Such "cross-talk" phenomenon may be increased in the lower pixels, thereby causing deterioration in display quality of the OLED device.

FIG. 9 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a fourth exemplary embodiment of the present invention. In this embodiment, the power supply line Vdd is expanded in the row direction and arranged parallel with the gate lines, thereby effectively reducing the "cross-talk" phenomenon. Referring to FIG. 9, the pixel driving unit according to the fourth embodiment of the present invention includes first to third thin film transistors T₁-T₃ each having a switching function, fourth and fifth thin film transistors T₄, T₅ each having a driving function, a storage capacitor Cst, and an OLED diode connected to a common electrode voltage V_{COM}, which are the elements mainly constituting a unit pixel of the OLED device. The pixel driving units are arranged in a matrix form in the OLED device such that each pixel driving unit is defined in a region surrounded by two adjacent gate lines each for transferring a gate signal and two adjacent data lines each for transferring a data signal. In FIG. 9, the parts equivalent to those in FIG. 3 are represented with like reference numerals and description thereof is omitted to avoid duplication. In this embodiment, the gate of the fifth thin film transistor T₅ is connected to the present gate line G_q, so that the fifth thin film transistor T₅ is turned on or off in response to a gate signal provided through the present gate signal.

In the operation of the pixel driving unit in FIG. 9, when an active gate signal (e.g., a high-level pulse signal) is applied to the previous gate line G_{q-1}, the first, third and fourth thin film transistors T₁, T₃, T₄ are turned off and the second and fifth thin film transistors T₂, T₅ are turned on. As a result, the reference voltage Vref supplied from a reference voltage line is applied to the gate of the fourth thin film transistor T₄. The reference voltage Vref used in this embodiment is the same as the one described in Equation 1.

When an active gate signal is applied to the present gate line G_q, the first thin film transistor T₁ is turned on so that a data signal applied from the data line D_p to the source of the first thin film transistor T₁ is transferred to the drain of the third thin film transistor T₃. At this time, the storage capacitor Cst charged with the data signal voltage Vdata provides a high-level voltage to the gate of the third thin film transistor T₃, so that the third thin film transistor T₃ is turned on. Thus, the data signal passing through the first and third thin film transistors T₁, T₃ is supplied to the gate of the fourth thin film transistor T₄. Then, the fourth thin film

transistor T₄ provides the bias voltage to the fifth thin film transistor through its conduction path in response to the data signal applied to its gate. The fifth thin film transistor T₅ is turned off when a signal of the present gate line G_q becomes logic high. Subsequently, when the previous gate line signal becomes logic high and the present gate line signal becomes logic low, the fifth thin film transistor T₅ is turned on and maintains the active (i.e., turned-on) state until the next frame.

In this embodiment, as described above, the “cross-talk” phenomenon is effectively eliminated by disposing the power supply line expanded in the row direction parallel with the gate lines, while compensating the driving operation of the pixel driving units for varying characteristics of the fourth thin film transistor T₄ in different pixel driving units.

FIG. 10 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a fifth exemplary embodiment of the present invention. In FIG. 10, the same parts as those shown in FIG. 3 are represented with light reference numerals. In this embodiment, the power supply line is expanded in the row direction parallel with the gate lines and an additional thin film transistor T₆ is provided between the fifth thin film transistor and the OLED diode.

Referring to FIG. 10, the pixel driving unit includes first to third thin film transistors T₁–T₃ each having a switching function, fourth to sixth thin film transistors T₄–T₆ each having a driving function, a storage capacitor Cst, and the OLED diode connected to a common electrode voltage V_{COP}, which are the elements mainly constituting a unit pixel of the OLED device. Each of the pixel driving units of the OLED device is disposed in a region surrounded by adjacent gate lines each for transferring a gate signal and adjacent data lines each for transferring a data signal. In this embodiment, the fifth thin film transistor T₅ is a P-type thin film transistor and has the gate connected to the previous gate line G_{q-1} so as to be turned on or off in response to a gate signal provided through the previous gate signal. Also, the sixth thin film transistor T₆ is an N-type thin film transistor and has the source connected to the drain of the fifth thin film transistor T₅, the drain connected to the OLED diode, and the gate connected to the present gate line G_q. The sixth thin film transistor T₆ is thus turned on or off in response to a gate signal applied through the present gate signal G_q.

In operation, when an active gate signal is applied to the previous gate line G_{q-1}, the first, third, fourth, fifth and sixth thin film transistors T₁, T₃, T₄, T₅, T₆ are turned off and the second thin film transistor T₂ is turned on. Thus, the reference voltage Vref supplied from a reference voltage line is applied to the gate of the fourth thin film transistor T₄. The reference voltage Vref is the same as the one described in Equation 1.

When an active gate signal is applied to the present gate line G_q, the first thin film transistor T₁ is turned on so that a data signal applied from the data line D_p to the source of the first thin film T₁ transistor is transferred to the drain of the third thin film transistor T₃ through the conduction path of the first thin film transistor T₁. Also, the second thin film transistor is turned off because the previous gate line is inactivated. Thus, the data signal passing through the first and third thin film transistors T₁, T₃ is supplied to the gate of the fourth thin film transistor T₄. Accordingly, the conduction path of the fourth thin film transistor is controlled by the data signal provided from the source of the third thin film transistors T₃.

In this embodiment, as mentioned for the fourth embodiment above, the “cross-talk” phenomenon existing between adjacent pixels arranged in the column direction is effectively eliminated by aligning the power supply line expanded in the row direction parallel with the gate lines.

In the pixel driving units of the first through fifth embodiments of the present invention, the first and second thin film transistors T₁, T₂ are N-type thin film transistors and the third to fifth thin film transistors T₃, T₄, T₅ are P-type thin film transistors. However, the present invention is not limited to such configuration. For example, a pixel driving unit of the present invention may include first to fourth thin film transistors T₁–T₄ which one is P-type thin film transistors and a fifth thin film transistor T₅ which is an N-type thin film transistor.

FIG. 11 is a circuit diagram illustrating a pixel driving unit for an OLED device according to a sixth exemplary embodiment of the present invention, and FIG. 12 is a graphical view of signal waveforms applied to the pixel driving unit in FIG. 11. Referring to FIG. 11, the pixel driving unit includes first to third thin film transistors T₂₁–T₂₃ each having a switching function, fourth and fifth thin film transistors T₂₄, T₂₅ each having a driving function, a storage capacitor Cst, and an OLED diode connected to a common electrode voltage V_{COP}, which constitute a unit pixel of the OLED device. The pixel driving unit is disposed in a region surrounded by adjacent gate lines for transferring gate signals and adjacent data lines for transferring data signals. Since the first to fourth thin film transistors T₂₁–T₂₄ are P-type thin film transistors, they are each turned on when a gate signal having a level lower than its threshold voltage is applied to the gate of the corresponding one of the first to fourth thin film transistors T₂₁–T₂₄. The fifth thin film transistor T₂₅ is an N-type thin film transistor, thus it is turned on when a gate signal having a level higher than its threshold voltage is applied to the gate of the fifth thin film transistor T₂₅.

As shown in FIG. 12, the gate signals respectively applied to the gate lines are inverted signals. In other words, since the first thin film transistor T₂₁ is a P-type thin film transistor, the first thin film transistor T₂₁ is maintained inactive when the gate signal applied to the current gate line G_q has a high-level. In contrast, the first thin film transistor T₂₁ is maintained active when the gate signal applied to the current gate line G_q has a low-level (i.e., active low signal). In order to supply such inverted gate signals to the pixel driving unit for the OLED device, an inverter is provided in a gate driver that sequentially outputs the gate signals.

In the operation of the pixel driving unit, when the previous gate line is activated (i.e., a low-level gate signal is applied to the previous gate line G_{q-1} and a high-level gate signal is applied to the current gate line), the first, third, fourth and fifth thin film transistors T₁, T₃, T₄, T₅ are turned off and the second thin film transistor T₂ is turned on. Thus, the reference voltage Vref is applied to the gate of the fourth thin film transistor T₄. In this case, the reference voltage Vref may be defined as following Equations 7 and 8.

$$V_{ref} < V_{gate-off(T21)} \quad \text{Equation 7}$$

Here, V_{gate-off(T21)} is a gate-off voltage of the first thin film transistor T₂₁.

$$V_{ref} < [V_{data,min} + V_{th(T23)}] \quad \text{Equation 8}$$

Here, V_{data,min} is the minimum voltage value of a data signal applied to the data line D_p, and V_{th(T23)} is the threshold voltage of the third thin film transistor T₂₃.

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Next, when the current gate line G_q is activated (i.e., a low-level gate signal is applied to the current gate line G_q and a high-level gate signal is applied to the previous gate line G_{q-1}), the first thin film transistor T_{21} is turned on so that a data signal applied to the source of the first thin film transistor T_{21} is transferred to the drain of the third thin film transistor T_{23} . At this time, since the storage capacitor Cst charge with the data signal voltage provides a high-level voltage to the gate of the third thin film transistor T_{23} , the third thin film transistor T_{23} is turned on. Thus, the data signal passing through the first and third thin film transistor T_{21} , T_{23} is supplied to the gate of the fourth thin film transistor T_{24} . At this time, an effective gate-source voltage $V_{gs'}(T_{24})$ determining the intensity of current flowing the fourth thin film transistor T_{24} is represented by following Equation 9.

$$V_{gs'}(T_{24}) = V_{gs}(T_{24}) - V_{th}(T_{24}) \quad \text{Equation 9}$$

Here, the gate-source voltage of the fourth thin film transistor T_{24} is the difference between the gate voltage of the fourth thin film transistor T_{24} and the bias voltage V_{dd} . The gate-source voltage is represented by following Equation 10.

$$V_{gs}(T_{24}) = V_{g(T_{24})} - V_{dd} \quad \text{Equation 10}$$

Here, the gate voltage of the fourth thin film transistor T_{24} is the difference between the data voltage and the threshold voltage of the third thin film transistor T_{23} , and it is represented by following Equation 11.

$$V_{g(T_{24})} = V_{data} + V_{th}(T_{23}) \quad \text{Equation 11}$$

Here, since the characteristics of the third and fourth thin film transistors T_3 , T_4 are substantially identical to each other, threshold voltage V_{th} of the third thin film transistor T_{23} is the same as that of the fourth thin film transistor T_{24} as follows.

$$V_{th}(T_{23}) = V_{th}(T_{24}) \quad \text{Equation 12}$$

Therefore, from Equations 9 through 12, the effective gate-source voltage of the fourth thin film transistor T_{24} is obtained as following Equation 13.

$$V_{gs'}(T_{24}) = V_{data} - V_{dd} \quad \text{Equation 13}$$

As expressed in Equation 13, the effective gate-source voltage $V_{gs'}(T_{24})$ determining the intensity of current flowing the fourth thin film transistor T_{24} is the voltage difference between the data voltage V_{data} applied through the data line D_p and the bias voltage V_{dd} applied through the external power supply line. Accordingly, the effective gate-source voltage $V_{gs'}(T_{24})$ of each of the fourth thin film transistors T_{24} respectively disposed in all the pixel driving units is only dependent on the intensity of the data voltage V_{data} applied through the data line D_p and the bias voltage V_{dd} applied through the external power supply line. The gate-source voltage $V_{gs'}(T_{24})$ is, however, independent of the threshold voltage V_{th} of the fourth thin film transistor T_{24} .

In this embodiment, the pixel driving unit compensates the driving operation of the fourth thin film transistor T_4 for its varying characteristics such that the threshold voltage V_{th} of a fourth thin film transistor T_4 in a pixel driving unit may be different from that of another fourth thin film transistor in another pixel driving unit. With such a compensation, the same current is provided to the OLED diode in response to the same data signal independent of the threshold voltage of the fourth thin film transistor T_4 , even when the driving transistors (i.e., the fourth thin film transistors T_{24}) have different threshold voltages in different

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pixel driving units. It is assumed that the pixel driving unit of the present invention has the third and fourth thin film transistors of which characteristics (e.g., threshold voltages) are similar or substantially identical to each other.

The thin film transistors employed in the pixel driving units for an OLED device according to the present invention each have a multi-layered structure including a semiconductor layer, an insulation layer, a protection layer and an electrode layer. The semiconductor layer includes amorphous silicon or polysilicon. The insulation layer includes silicon nitride (SiN_x), silicon oxide (SiO_2), aluminum oxide (Al_2O_3) and tantalum oxide ($TaOx$). The protection layer includes transparent organic insulating material or insulating material. The electrode layer includes conductive metal, for example, Al, Cr and Mo. Each of the multiple layers is fabricated as a thin film by using a deposition apparatus, such as a sputtering device and a chemical vapor deposition device. Then, the thin films are subjected to a lithography process to form the elements of the pixel driving units for the OLED device.

Of the multiple layers, the semiconductor layer serves as an electrical conduction channel through which electrons are moved, and the electrode layer includes a source electrode, a drain electrode and a gate electrode. The source electrode applies a voltage signal to the semiconductor layer, and the voltage signal traveling the semiconductor layer is output through the drain electrode. The gate electrode is a means for controlling (e.g., switching) the current flow from the source electrode to the drain electrode.

Thus, the thin film transistors with such configuration may be used as switching devices in an active matrix type OLED device. The thin film transistors of the active matrix type OLED device each have a semiconductor layer made of material including cadmium selenide ($CdSe$), hydrogenous amorphous silicon ($a-Si:H$), or poly crystalline silicon ($poly-Si$).

The amorphous silicon can be processed at a low temperature with a simple process, so that it has been used for a large-scale device, for example, a solar cell. In addition, a semiconductor manufacturing process using the amorphous silicon may be carried out in a low temperature processing system at the maximum temperature of about $350^\circ C$, so that the semiconductor device can be easily fabricated in case of using the amorphous silicon. However, electrons in the amorphous silicon move at a very low speed, thereby deteriorating switching characteristics of the thin film transistors. In addition, it is difficult to integrate driving circuitry controlling the thin film transistors at a high speed with the thin film transistors. In contrast, a thin film transistor having a semiconductor layer including polysilicon is adapted for the active matrix type OLED device.

Although the thin film transistor having the semiconductor layer including polysilicon requires an additional process, the polysilicon thin film transistor that serves as a switching device provided in the active matrix type OLED device has a response speed faster than that of the amorphous silicon thin film transistor. In addition, the polysilicon thin film transistor has superior field effect mobility as compared with that of the amorphous silicon thin film transistor. The field effect mobility determines a switching speed of the thin film transistor. The switching speed of the polysilicon thin film transistor is remarkably faster than the switching speed of the amorphous silicon thin film transistor.

This is because the polysilicon consists of various grains and has a low defect as compared with amorphous silicon. Thus, polysilicon can be used for a switching device in a

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next-generation OLED device having a large screen while allowing the drive circuitry to be integrated with the thin film transistor. The polysilicon thin film transistor may be fabricated through a solid phase crystallization (SPC) process in which amorphous silicon is crystallized at a high temperature, a metal induced crystallization (MIC) process in which heat is applied to metal deposited on amorphous silicon, or an excimer laser annealing process using a laser. The excimer laser annealing process can be carried out at a low temperature with using an inexpensive glass substrate, so it can save manufacturing cost. In addition, the thin film transistor manufactured through the excimer laser annealing process has high mobility of signals, so that the operational characteristic of a semiconductor device is improved.

Hereinafter, methods of fabricating a polysilicon thin film transistor by crystallizing an amorphous silicon thin film transistor using a laser will be described with reference to the accompanying drawings.

FIGS. 13A and 13B are schematic diagrams each illustrating two thin film transistors fabricated according to an exemplary embodiment of the present invention. The two thin film transistors are the third and fourth thin film transistors T₃ (or T₂₃), T₄ (or T₂₄) in the pixel driving unit of the present invention (referring to FIGS. 3-11). As described above, the third and fourth thin film transistors in the pixel driving unit have the characteristics similar or substantially identical to each other. According to a method of fabricating the two thin film transistors, a polysilicon thin film transistor is formed by crystallizing an amorphous silicon thin film transistor using a laser scan, and the third and fourth thin film transistors T₃ and T₄ are formed in the same plane.

Referring to FIG. 13A, the third and fourth amorphous silicon thin film transistors T₃ and T₄ are formed on the same plane of a glass substrate. The gate electrodes G of the third and fourth amorphous silicon-thin film transistors T₃ and T₄ are formed in parallel to each other, and the source and drain electrodes S, D of the third and fourth amorphous silicon-thin film transistors T₃ and T₄ are formed to be collinearly arranged (i.e., aligned in a same line) in a direction substantially perpendicular to the laser scan direction that is substantially parallel to the gate electrodes G. Then, the amorphous silicon thin film transistors T₃, T₄ are subjected to the laser scan to be crystallized and transformed into the polysilicon thin film transistors.

FIG. 13B is a schematic diagram for describing a method of fabricating the third and fourth thin film transistors T₃ and T₄ according to another embodiment of the present invention. The third and fourth amorphous silicon thin film transistors T₃ and T₄ are formed on the same plane of the glass substrate. Then, the gate electrodes G of the third and fourth amorphous silicon thin film transistors T₃ and T₄ are collinearly formed, and the source and drain electrodes S, D of the third and fourth amorphous silicon-thin film transistors T₃, T₄ are formed substantially parallel to the laser scan direction. The gate electrodes G are formed in a collinear direction substantially perpendicular to the laser scan direction. Upon being subjected to the laser scan, the amorphous silicon-thin film transistors are crystallized and transformed into the polysilicon thin film transistors.

When crystallizing the amorphous silicon-thin film transistors through the laser annealing process, a mask for forming a laser beam pattern on the glass substrate and a zoom lens for exposing a pattern of the mask to the glass substrate by zooming-out the pattern are prepared. In detail, a laser beam is adjusted to have a uniform distribution, and the laser beam pattern to be formed on the glass substrate

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through the mask is determined. For example, a light source is employed to generate a line beam from its tip. In this case, a line-shaped mask is also used. In other method, another mask in addition to the line-shaped mask may be used between the glass substrate and the light source to form a specific pattern.

Then, the laser beam is adjusted to have a selected beam width by means of a zoom-out lens. In case of employing the line-shaped mask alone, the beam width is in a range from several millimeters to several centimeters and the length is from several centimeters to several tens centimeters (or up to about 2 meters). In case of employing another mask in addition to the line-shaped mask, the beam width is in a range from several micrometers to several millimeters. The amorphous silicon thin film transistors are crystallized by radiating the laser beam onto the glass substrate while moving the glass substrate or the laser beam on the X-Y plane, so that the amorphous silicon thin film transistors are transformed into the polysilicon thin film transistors.

FIG. 14 is a plan view of the pixel driving unit for an OLED device in FIG. 3. FIGS. 15 and 16 are cross-sectional views of the pixel driving unit taken along lines A-A' and B-B', respectively, in FIG. 14. As shown in FIGS. 15 and 16, the pixel driving unit is formed in multiple layers, such as an insulation substrate 10 including glass, quartz, and/or sapphire, a blocking layer 20, a gate insulating layer 30, an interlayer dielectric 40, and a passivation layer 50.

Referring to FIGS. 14 to 16, the blocking layer 20 is formed on the glass substrate 20 by depositing silicon oxide on the glass substrate 20 at a thickness of about 2000 Å through a plasma-enhanced chemical vapor deposition process. On the blocking layer 20, five thin film transistors T₁-T₅, one storage capacitor C, and five wirings Gn-1, Gn, DL, Vdd, V_{ref} are formed. The blocking layer 20 is provided to prevent thermal loss while crystallizing an amorphous-silicon layer to form a polysilicon layer.

One pixel driving unit is defined by first and second gate lines Gn-1, Gn extending in a first direction, a data line DL extending in a second direction substantially perpendicular to the first direction, and a power supply line Vdd extending in the second direction. A reference voltage line V_{ref} extends in the first direction and is disposed between the first and second gate lines Gn-1, Gn.

In detail, the first gate line Gn-1 turns on/off the first thin film transistor T₁ of a pixel driving unit in the previous column, so that an initial data signal and a gray-scale data signal are provided through the data line DL. Also, the first gate line Gn-1 turns on/off the second and fifth thin film transistors T₂, T₅ of the pixel driving unit in the current column.

The second gate line Gn turns on/off the first thin film transistor T₁ of the pixel driving unit in the current column to perform a switching function, so that an initial data signal and a gray-scale data signal are provided to the pixel driving unit through the data line DL. Also, the second gate line Gn turns on/off the second and fifth thin film transistors T₂, T₅ of a pixel driving unit in the next column. Through the power supply line Vdd, the maximum value of a display signal is constantly applied in the form of direct current to the pixel driving unit. Through the reference voltage line, the reference voltage V_{ref} is applied to the second thin film transistor T₂.

Referring to FIG. 14, the first thin film transistor T₁ includes a first active pattern 110 disposed at an area adjacent to a cross point between the second gate line Gn and the data line DL, a gate electrode 112 extending from the second gate line Gn and passing above the first active pattern

110, a source electrode **114** extending from the data line **DL** and making contact with the first active pattern **110** aligned at one side of the gate electrode **112**, and a first drain electrode **116** making contact with the first active pattern **110** aligned at the other side of the gate electrode **112**. The gate electrode **112** and the source electrode **114** of the first thin film transistor **T₁** are connected to the second gate line **Gn** and the data line **DL**, respectively.

The second thin film transistor **T₂** includes a second active pattern **120**, a gate electrode **122** extending from the first gate line **Gn-1** and passing above the second active pattern **120**, a source electrode **124** extending from the reference voltage line **V_{ref}** and making contact with the second active pattern **120** aligned at one side of the gate electrode **122**, and a drain electrode **126** making contact with the second active pattern **120** aligned at the other side of the gate electrode **122**.

The third thin film transistor **T₃** includes the first active pattern **110**, a gate electrode **132** extending from a metal line **G_M**, which is formed when the first gate line **Gn-1** is formed, and passing above the first active pattern **110**, a source electrode **134** extending from the reference voltage line **V_{ref}** and making contact with the first active pattern **110** aligned at one side of the gate electrode **132**, and a drain electrode **136** making contact with the first active pattern **110** aligned at the other side of the gate electrode **132**.

The fourth thin film transistor **T₄** includes a third active pattern **140**, a gate electrode **142** extending from the metal line **G_M** and passing above the third active pattern **140**, a source electrode **144** extending from the reference voltage line **V_{ref}** and making contact with the third active pattern **140** aligned at one side of the gate electrode **142**, and a drain electrode **146** making contact with the third active pattern **140** aligned at the other side of the gate electrode **142**.

The fifth thin film transistor **T₅** includes a fourth active pattern **150**, a gate electrode **152** extending from the first gate line **Gn-1** and passing above the fourth active pattern **150**, a source electrode **154** extending from the drain electrode **147** of the fourth thin film transistor **T₄** and making contact with the fourth active pattern **150** aligned at one side of the gate electrode **152**, and a drain electrode **156** making contact with the fourth active pattern **150** aligned at the other side of the gate electrode **152** and making contact with an anode electrode of the OLED device.

In this embodiment, the first and second thin film transistors **T₁**, **T₂** are N-type thin film transistors, and the third to fifth thin film transistors **T₃-T₅** are P-type thin film transistors. The storage capacitor **Cst** is defined by the metal line **G_M** formed when forming the first gate line and the power supply line **Vdd** formed above the metal line **G_M**. The storage capacitor **Cst** constantly maintains data voltage for one frame time.

After forming the five thin film transistors **T₁-T₅**, the storage capacitor **Cst**, and the five wirings **Gn-1**, **Gn**, **DL**, **Vdd**, **V_{ref}**, an ITO anode electrode is formed on the top portion of the pixel driving unit and exposed through an opening. Also, a hole transfer layer, a light emitting layer and an electron transfer layer are sequentially formed on an organic insulating wall of the pixel driving unit, and a cathode electrode is formed thereon. In this embodiment, the third and fourth thin film transistors are disposed in a direction parallel to the data line, so that the characteristics of the third and fourth thin film transistors become similar or substantially identical to each other when the amorphous silicon-thin film transistors are crystallized through a laser scan process.

As described above, the pixel driving unit according to the present invention compensates for the threshold voltage of a driving thin film transistor in the respective pixel driving units of an OLED device. The effective gate-source voltage of the driving thin film transistor is only dependent on a data voltage and a bias voltage externally applied and independent of the threshold voltage of the driving thin film transistor, so that each OLED diode receives a driving signal with the same intensity in response to the same data signal.

While the invention has been described with reference to the exemplary embodiments, it will be understood by those skilled in the art that various changes may be made and equivalents may be substituted for elements thereof without departing from the scope of the invention. In addition, many modifications may be made to adapt a particular situation or material to the teachings of the invention without departing from the essential scope thereof. Therefore, it is intended that the invention may not be limited to the particular embodiment disclosed as the best mode contemplated for carrying out this invention, but that the invention will include all embodiments falling within the scope of the intended claims.

What is claimed is:

1. An apparatus for providing a driving signal to an organic light emitting diode in an image display device, comprising:

first and second control lines for transferring previous and current control signals, respectively, in a sequential process for providing the driving signal to the organic light emitting diode;

a data line for transferring a data signal for displaying images on the image display device;

a first switching device including a conduction path for transferring the data signal from the data line, the conduction path of the first switching device being controlled by the current control signal from the second control line;

a second switching device including a conduction path for transferring a reference signal externally supplied, the conduction path of the second switching device being controlled by the previous control signal from the first control line;

a third switching device including a conduction path for transferring the data signal provided from the first switching device, the conduction path of the third switching device being controlled by a state of the second switching device;

a fourth switching device including a conduction path for transferring a bias voltage, the conduction path of the fourth switching device being controlled by one of the reference signal from the second switching device and the data signal from the third switching device; and

a fifth switching device including a conduction path for receiving a bias voltage from the fourth switching device and generating the driving signal to the organic light emitting diode, the conduction path being controlled by the previous gate signal from the first gate line.

2. The apparatus of claim **1**, wherein the third and fourth switching devices have switching characteristics substantially identical to each other.

3. The apparatus of claim **2**, further including a capacitor for being charged with the bias voltage and for providing a voltage signal to control the conduction path of the third switching device.

4. The apparatus of claim **3**, wherein the first, second, third and fourth switching devices are first, second, third and

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fourth thin film transistors, respectively, each having a conduction path between a source and a drain and a gate for receiving a control signal to control the conduction path; the first and second control signal lines are first and second gate lines, respectively; and the previous and current control signals are previous and current gate signals, respectively.

5. The apparatus of claim 4, wherein the first, second, third and fourth thin film transistors are polysilicon thin film transistors.

6. The apparatus of claim 4, wherein the first thin film transistor has a gate to which the current gate signal is applied from the second gate line and a source and a drain to form the conduction path for transferring the data signal; the second thin film transistor has a gate to which the previous gate signal is applied from the first gate line and a source and a drain to form the conduction path for transferring the reference signal; the third thin film transistor has a gate to which the voltage signal from the capacitor is applied and a source and a drain to form the conduction path for transferring the data signal; and the fourth thin film transistor has a gate to which one of the reference signal from the second thin film transistor and the data signal from the third thin film transistor is applied and a source and a drain to form the conduction path between the bias voltage and the fifth switching device.

7. The apparatus of claim 6, wherein the conduction path of the second thin film transistor and the conduction path of the third thin film transistor are connected to the gate of the fourth thin film transistor and are parallel to each other with respect to the gate of the fourth thin film transistor.

8. The apparatus of claim 6, wherein the gate of the third thin film transistor is connected with the gate of the fourth thin film transistor.

9. The apparatus of claim 6, wherein the third and fourth thin film transistors have a substantially identical threshold voltage.

10. The apparatus of claim 9, wherein the threshold voltage of the third and fourth thin film transistors has a negative value.

11. The apparatus of claim 6, wherein the first and second thin film transistors are N-type thin film transistors, and the third and fourth thin film transistors are P-type thin film transistors.

12. The apparatus of claim 11, wherein the voltage of the reference signal is equal to or larger than a gate-off voltage of the first thin film transistor and is equal to or less than a sum of a threshold voltage of the third thin film transistor and a minimum voltage value of the data signal.

13. The apparatus of claim 6, wherein an effective gate-source voltage of the fourth thin film transistor is dependent on the bias voltage and the data signal and independent of a threshold voltage of the fourth thin film transistor.

14. The apparatus of claim 6, wherein the bias voltage is provided from a power supply line disposed substantially parallel with the data line.

15. The apparatus of claim 6, wherein the fifth switching device is a fifth thin film transistor having a conduction path between a source and a drain and a gate for receiving a control signal to control the conduction path,

wherein the conducting path is between the fourth thin film transistor and the organic light emitting diode, the conduction path being controlled by the previous gate signal from the first gate line.

16. The apparatus of claim 15, wherein the fifth thin film transistor is a P-type thin film transistor having a source and a drain forming the conduction path and a gate receiving the previous gate signal.

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17. The apparatus of claim 6, wherein the source of the second thin film transistor is connected with the second gate line, so that the conduction path of the second thin film transistor transfers the current gate signal to the fourth thin film transistor as the reference signal.

18. The apparatus of claim 6, wherein the bias voltage is provided from a power supply line disposed substantially parallel with the first and second gate lines.

19. The apparatus of claim 18, further including a fifth thin film transistor having a conduction path between the fourth thin film transistor and the organic light emitting diode, the conduction path being controlled by the current gate signal from the second gate line.

20. The apparatus of claim 19, wherein the fifth thin film transistor is a P-type thin film transistor having a source and a drain forming the conduction path and a gate receiving the current gate signal.

21. The apparatus of claim 18, further including:
a fifth thin film transistor having a conduction path for transferring the driving signal from the fourth thin film transistor, the conduction path being controlled by the previous gate signal from the first gate line; and
a sixth thin film transistor having a conduction path for transferring the driving signal from the fifth thin film transistor to the organic light emitting diode, the conduction path of the sixth thin film transistor being controlled by the current gate signal from the second gate line.

22. The apparatus of claim 21, wherein the fifth thin film transistor is a P-type thin film transistor having a source and a drain forming the conduction path for transferring the driving signal from the fourth thin film transistor and a gate receiving the previous gate signal, and the sixth thin film transistor is an N-type thin film transistor having a source and a drain forming the conduction path for transferring the driving signal from the fifth thin film transistor and a gate receiving the current gate signal.

23. The apparatus of claim 6, further comprising a fifth thin film transistor having a conduction path between the fourth thin film transistor and the organic light emitting diode, the conduction path being controlled by the previous gate signal from the first gate line,

wherein the first, second, third and fourth thin film transistors are P-type thin film transistors, and the fifth thin film transistor is an N-type thin film transistor.

24. The apparatus of claim 23, wherein the reference voltage is larger than a gate-off voltage of the first thin film transistor.

25. The apparatus of claim 24, wherein the reference voltage is smaller than a sum of a threshold voltage of the third thin film transistor and a minimum voltage value of the data signal.

26. An organic light emitting display device comprising:
a plurality of gate lines to which an active gate line is sequentially supplied;

a plurality of data lines to which data signals are applied to display images on the organic light emitting display device; and

a plurality of pixel driving units each of which provides a driving signal to a corresponding OLE diode in association with a pair of the gate lines and at least one of the plurality of data lines, wherein each of the pixel driving units includes:

a first driving transistor having a conduction path with one terminal receiving a bias voltage and the other terminal providing the bias voltage to second driving transistor, wherein the second driving transistor has a conduction

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- path with one terminal receiving the bias voltage and the other terminal providing the driving signal to the diode;
- a first switching transistor having a conduction path for transferring a reference signal, the conduction path of the first switching transistor being controlled by a previous gate signal; and
- a second switching transistor having a conduction path for transferring a data signal, the conduction path of the second switching transistor being controlled by a state of the first switching transistor,
- wherein the conduction path of the first driving transistor is controlled by one of the reference signal from the first switching transistor and the data signal from second switching transistor.
- 27.** The organic light emitting display device of claim 26, wherein a plurality of gate lines including a dummy gate line for providing a gate signal to the first switching transistor of a first one of the pixel driving units.
- 28.** The organic light emitting display device of claim 27, wherein the dummy gate line is synchronized with a last one of the gate lines.
- 29.** The organic light emitting display device of claim 27, wherein a same gate signal is applied to the dummy gate line and a last one of the gate lines simultaneously.
- 30.** The organic light emitting display device of claim 26, wherein each of the pixel driving units further includes a

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third switching transistor having a conduction path for transferring the data signal from a corresponding one of the data lines to the second switching transistor, the conduction path of the third switching transistor being controlled by the current gate signal.

31. The organic light emitting display device of claim 26, wherein the first driving transistor and the second switching transistor have a substantially identical threshold voltage.

32. The organic light emitting display device of claim 26, further including a plurality of power supply lines each of which is associated with a corresponding one of the pixel driving units for providing the bias voltage to the corresponding pixel driving unit, wherein the power supply lines are parallel with the data lines.

33. The organic light emitting display device of claim 26, further including a plurality of power supply lines each of which is associated with a corresponding one of the pixel driving units for providing the bias voltage to the corresponding pixel driving unit, wherein the power supply lines are parallel with the gate lines.

34. The organic light emitting display device of claim 26, wherein the first driving transistor, and first and second switching transistors are thin film transistors each having a source and a drain forming a conduction path and a gate receiving a gate signal to control the conduction path.

* * * * *

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摘要(译)

用于向图像显示装置中的有机发光二极管提供驱动信号的装置包括用于在顺序处理中分别传输先前和当前栅极信号的栅极线，用于向有机发光二极管提供驱动信号，数据线为了在图像显示装置上传输用于显示图像的数据信号，第一开关晶体管包括用于响应于当前栅极信号从数据线传输数据信号的传导路径，第二开关晶体管，包括用于传输响应于先前栅极信号而外部提供的参考信号的导电路径，第三开关晶体管，包括用于响应于第二开关晶体管的状态传输从第一开关晶体管提供的数据信号的导电路径，第四开关晶体管，包括用于接收偏置电压的导电路径，并响应于来自第二开关晶体管的参考信号和来自第三开关晶体管的数据信号之一产生驱动信号到有机发光二极管。第三和第四开关晶体管具有彼此基本相同的开关特性。

